

# CE/EMC COMPLIANCE REPORT

for

CHIPSEE CO., LIMITED.

Embedded Industrial Computer

Prepared for : CHIPSEE CO., LIMITED.

Address : Xinyuan Science Park B406, 97 Changping Road, Changping  
District, Beijing, 102206, China

Prepared by : EST Technology Co., Ltd.

Address : Chilingxiang, Qishantou, Santun, Houjie, Dongguan,  
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Report Number : ESTE-E2105004

Date of Report : May 08, 2021

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## EST Technology Co., Ltd.

<b>Applicant:</b>	CHIPSEE CO., LIMITED.		
<b>Address:</b>	Xinyuan Science Park B406, 97 Changping Road, Changping District, Beijing, 102206, China		
<b>Manufacturer:</b>	CHIPSEE CO., LIMITED.		
<b>Address:</b>	Xinyuan Science Park B406, 97 Changping Road, Changping District, Beijing, 102206, China		
<b>Factory:</b>	CHIPSEE CO., LIMITED.		
<b>Address:</b>	Xinyuan Science Park B406, 97 Changping Road, Changping District, Beijing, 102206, China		
<b>E.U.T:</b>	Embedded Industrial Computer		
<b>Model Number:</b>	CS12800RA4101A		
<b>Trade Name:</b>	Chipsee	<b>Serial No:</b>	-----
<b>Date of Receipt:</b>	Apr. 15, 2021	<b>Date of Test:</b>	Apr. 19~May 07, 2021
<b>Test Specification:</b>	EN 55032:2015+A11:2020 EN 55035:2017+A11:2020 EN IEC 61000-3-2:2019 EN 61000-3-3:2013+A1:2019		
<b>Test Result:</b>	The equipment under test was found to be compliance with the requirements of the standards applied.		
		<b>Issue Date: May 08, 2021</b>	
<b>Prepared by:</b>	<b>Reviewed by:</b>	<b>Approved by:</b>  Iceman Hu / Manager	
 _____ Lena / Assistant	 _____ Zack / Engineer		
<b>Other Aspects:</b>			
None.			
<i>Abbreviations: OK/P=passed    fail/F=failed    n.a/N=not applicable    E.U.T=equipment under tested</i>			
<i>This test report is based on a single evaluation of one sample of above mentioned products, It is not permitted to be duplicated in extracts without written approval of EST Technology Co., Ltd. The statement of compliance in this report is based on the limit in the test standard, the measurement uncertainty is not considered.</i>			

# 1. GENERAL PRODUCT INFORMATION

## 1.1. Product Function

Refer to Technical Construction Form and User Manual.

## 1.2. Description of Device (EUT)

Description	: Embedded Industrial Computer
Model No.	: CS12800RA4101A
System Input Voltage	: DC 9V~36V
Power	: 8.4 W
LAN Line	: Unshielded, Detachable 1.5m
DC Line	: Unshielded, Detachable 1.0m

## 1.3. Difference between Model Numbers

None.

## 1.4. Independent Operation Modes

The basic operation modes are:

1.4.1. TF Play

1.4.2. USB Play

1.4.3. LAN Mode

## 1.5. Test Supporting System

## 2. TEST SITES

### 2.1. Description of Standards and Results

The EUT have been tested according to the applicable standards as referenced below.

EMISSION(EN 55032:2015+A11:2020)				
Description of Test Item	Standard	Limits		Results
Conducted emissions (AC mains power ports)	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 21.45dB at 2.54MHz		
Asymmetric mode conducted emissions	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 19.90dB at 0.41MHz		
Conducted differential voltage emissions	EN 55032:2015+A11:2020	----		N/A
		More than ** dB below the limit line.		
Radiated Emission	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 5.34dB at 141.55MHz		
Radiated Emission Test (above 1GHz)	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 9.38dB at 2130MHz		
Harmonic current emissions	EN IEC 61000-3-2:2019	Class A		N/A
Voltage fluctuations & flicker	EN 61000-3-3:2013+A1:2019	Section 4.6		PASS
IMMUNITY (EN 55035:2017+A11:2020)				
Description of Test Item	Basic Standard	Performanc e Criteria	Observation Criteria	Results
Electrostatic discharge (ESD)	EN 61000-4-2:2009	B	B	PASS
Radio-frequency,Continuous radiated disturbance	EN 61000-4-3:2006+A1: 2008+A2:2010	A	A	PASS
Electrical fast transient (EFT)	EN 61000-4-4:2012	B	B	PASS
Surge (Input a.c. power port)	EN 61000-4-5:2014	B	B	PASS
Radio-frequency, Continuous conducted disturbance	EN 61000-4-6:2014	A	A	PASS
Power frequency magnetic field	EN 61000-4-8:2010	A	A	PASS
Voltage dips, >95% reduction	EN 61000-4-11:2004	B	A	PASS
Voltage dips, 30% reduction		C	B	PASS
Voltage interruptions		C	B	PASS
N/A is an abbreviation for Not Applicable.				

## 2.2. Test Facilities

EMC Lab : Certificated by CNAS, CHINA  
Registration No.: L5288  
This Certificate is valid until: November 12, 2023

Certificated by FCC, USA  
Designation Number: CN1215  
This Certificate is valid until: January 31, 2022

Certificated by A2LA, USA  
Registration No.: 4366.01  
This Certificate is valid until: January 31, 2022

Certificated by Industry Canada  
CAB identifier No.: CN0035  
This Certificate is valid until: January 31, 2022

Certificated by VCCI, Japan  
Registration No.: C-14103; T-20073; R-13663;  
R-20103; G-20097  
Date of registration: Apr. 20, 2020  
This Certificate is valid until: Apr. 19, 2023

Certificated by TUV Rheinland, Germany  
Registration No.: UA 50413872 0001  
Date of registration: July 31, 2018

Certificated by Intertek  
Registration No.: 2011-RTL-L2-64  
Date of registration: November 08, 2018

Name of Firm : EST Technology Co., Ltd.

Site Location : Chilingxiang, Qishantou, Santun, Houjie, Dongguan,  
Guangdong, China



## 2.3.List of Test and Measurement Instruments

### 2.3.1. For conducted emission at the mains terminals test (1# conduction)

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESHS30	EST-E001	June 13,20	1 Year
Artificial Mains Network	Rohde & Schwarz	ENV216	EST-E002	June 13,20	1 Year
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	EST-E078	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

### 2.3.2. For asymmetric mode conducted emissions test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESPR3	EST-E070	June 13,20	1 Year
ISN	Teseq	T8	EST-E041	June 13,20	1 Year
Current Transformer	SCHWARZBECK	SW9605	EST-E045	June 13,20	1 Year
Voltage Probe	SCHWARZBECK	TK9420	EST-E046	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

### 2.3.3. For radiated emission test (2# 966 radiation)

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESCI3	EST-E071	June 13,20	1 Year
Bilog Antenna	Teseq	CBL 6111D	EST-E053	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

### 2.3.4. For radiated emission test (above 1GHz )

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESR7	EST-E047	June 13,20	1 Year
Horn Antenna	SCHWARZBECK	BBHA 9120 D	EST-E031	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

### 2.3.5. For harmonic current emissions and voltage fluctuations/flicker test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Power Analyzer	California Instruments	3001IX-208-CTS	EST-E011	June 13,20	1 Year
Voltage Source	California Instruments	3001IX-208	EST-E012	June 13,20	1 Year
Test Software	California Instruments	CTS	N/A	N/A	N/A

### 2.3.6. For electrostatic discharge immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
ESD Generator	HAEFELY	ONYX16	EST-E013	June 13,20	1 Year

### 2.3.7. For electrical fast transient/burst immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EFT Generator	EMC PARTNER	TRANSIENT 2000	EST-E074	June 13,20	1 Year
Capacitive Coupling Clamp	HAEFELY	IP4A	EST-E040	June 13,20	1 Year

### 2.3.8. Radio Frequency Electromagnetic Field Immunity (R/S) Test\

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Agilent	N5181A	EST-E060	June 13,20	1 Year
Power Amplifier	SKET	HAP801000M-250W	EST-E061	N/A	N/A
Power Amplifier	SKET	HAP0103G-75W	EST-E062	N/A	N/A
Power Amplifier	SKET	HAP0306G-50W	EST-E063	N/A	N/A
Power Meter	Agilent	E4419B	EST-E064	June 13,20	1 Year
Power sensor	Agilent	E9301A	EST-E065	June 13,20	1 Year
Power sensor	HP	E9301A	EST-E066	June 13,20	1 Year
Antenna	Schwarzbeck	STLP 9129	EST-E059	N/A	N/A
E-Field Probe	Narda	EP-601	EST-E067	June 13,20	1 Year
Audio Analyzer	Rohde &Schwarz	UPV	EST-E024	June 13,20	1 Year
Test Software	SKET	EMC-S	V1.2.0.48	N/A	N/A

### 2.3.9. For surge immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Surge Controller	HAEFELY	PSURGE8000	EST-E015	June 13,20	1 Year
Surge Impulse Module	HAEFELY	PIM100	EST-E016	June 13,20	1 Year
Surge Coupling Network	HAEFELY	PCD100	EST-E017	June 13,20	1 Year

### 2.3.10.For injected currents susceptibility test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Rohde &Schwarz	SMB100A	EST-E025	June 13,20	1 Year
Power Amplifier	FRANKONIA	CIT-10	EST-E021	June 13,20	1 Year
Power Meter	Rohde &Schwarz	NRVS	EST-E027	June 13,20	1 Year
Audio Analyzer	Rohde &Schwarz	UPV	EST-E024	June 13,20	1 Year
CDN	FRANKONIA	CDN-M2+M3	EST-E022	June 13,20	1 Year
EM-Clamp	FRANKONIA	EMCL-20	EST-E042	June 13,20	1 Year
Test Software	SKET	EMC-S	V1.2.0.80	N/A	N/A

### 2.3.11.For power frequency magnetic field immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Magnetic Field Tester	HAEFELY	MFS 100	EST-E018	June 13,20	1 Year

### 2.3.12.For voltage dips and short interruptions immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
DIPS Tester	EMC PARTNER	TRANSIENT 2000	EST-E074	June 13,20	1 Year

Note: All calibration reports of the equipment were provided by LiSai calibration and Testing



### 3. TEST SET-UP AND OPERATION MODES

#### 3.1. Principle of Configuration Selection

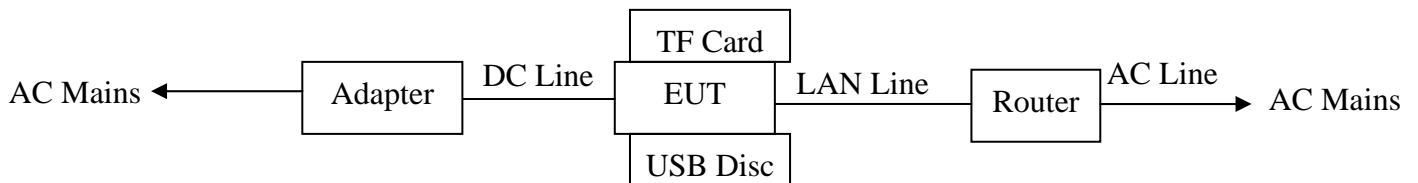
**Emission:** The equipment under test (EUT) was configured to measure its highest possible radiation level. The test modes were adapted accordingly in reference to the Operating Instructions.

**Immunity:** The equipment under test (EUT) was configured to the representative operating mode and conditions.

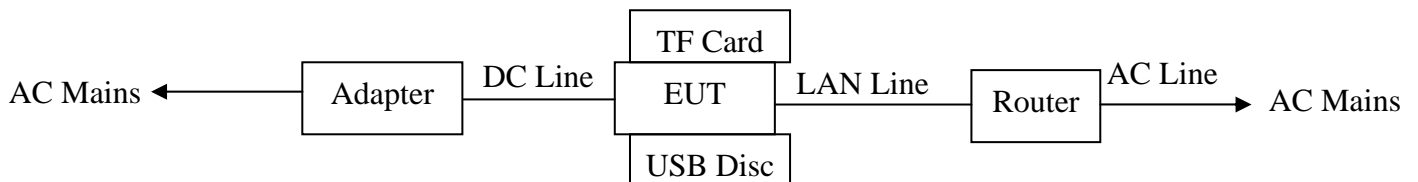
#### 3.2. Block Diagram of Test Set-up

System Diagram of Connections Between EUT and Simulators

##### 3.2.1. For emission test



##### 3.2.2. For immunity test



(EUT: Embedded Industrial Computer)

#### 3.3. Test Operation Mode and Test Software

Refer to Test Setup in clause 4 & 5.

#### 3.4. Special Accessories and Auxiliary Equipment

##### 3.4.1. Adapter

M / N	:	ADP-24F12
Input	:	AC 100-240V, 50-60Hz, 0.8A
Output	:	DC 12V, 2A

#### 3.4.2.U Disc

M / N : SDCZ7-4096  
S / N : BH0701AGOB  
Manufacturer : SanDisk

#### 3.4.3.Router

M / N : RT-AC66U  
S / N : G1ICGG000260  
Manufacturer : ASUS  
Ethernet Line : Shielded, Detachable 1.5m

#### 3.4.4.SD Card

M / N : SDSQUNC-032G-ZN6MA  
Manufacturer : SanDisk

### 3.5. Countermeasures to Achieve EMC Compliance

None.

## 4. EMISSION TEST RESULTS

### 4.1. Conducted Emission at the Mains Terminals Test

**RESULT** : **Pass**  
Test procedure : EN 55032:2015+A11:2020  
Frequency range : 0.15~30MHz  
Test Site : 1# Conduction Shielded Room  
Limits : EN 55032:2015+A11:2020 Class A

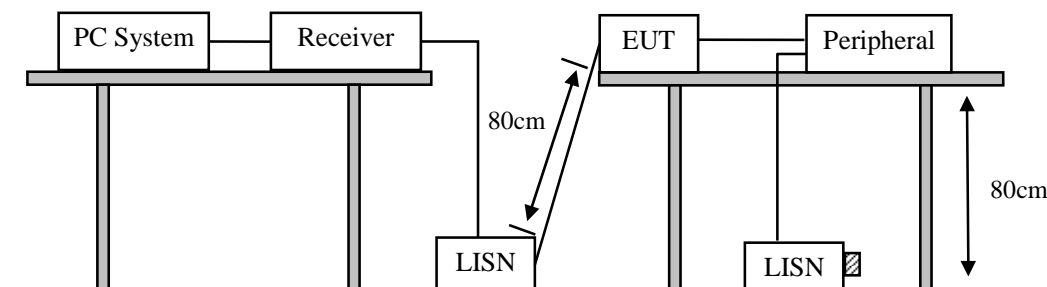
#### Test Setup

Date of test : Apr. 19, 2021  
Model No. : CS12800RA4101A  
Input Voltage : DC 12V From Adapter Input AC 230V/50Hz,  
DC 12V From Adapter Input AC 110V/60Hz  
Operation Mode : TF Play, USB Play, LAN Mode

The bandwidth of the test receiver was set at 9kHz.

The frequency range from 150 kHz to 30 MHz was investigated.

The test data of the worst case condition(s) was reported on the following page.

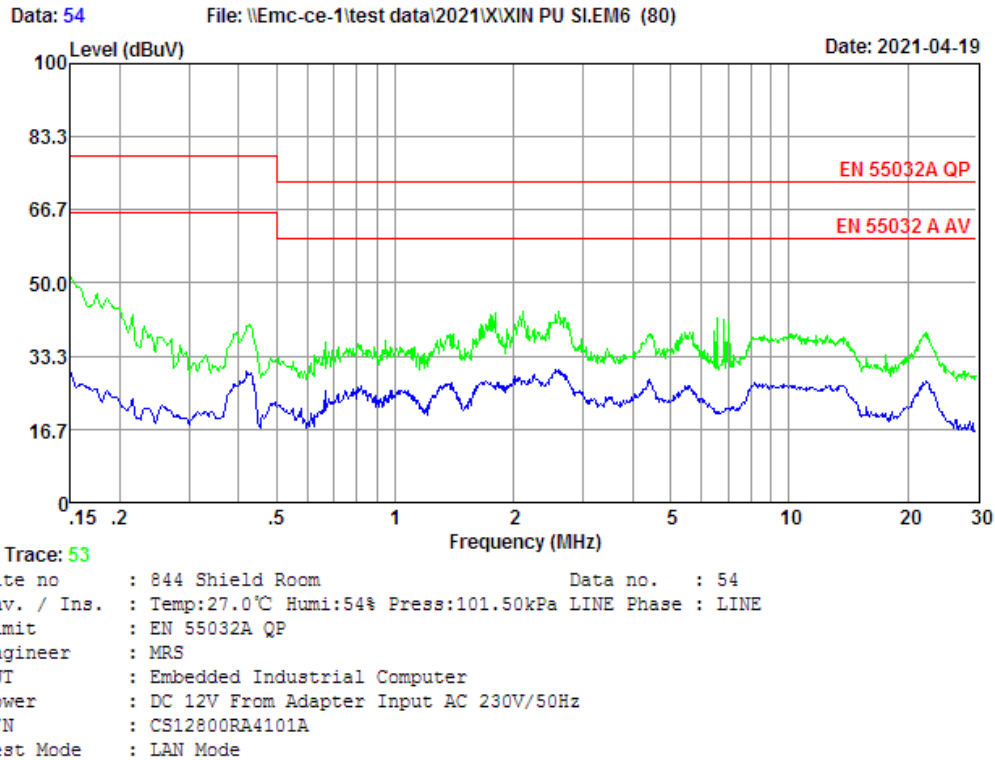


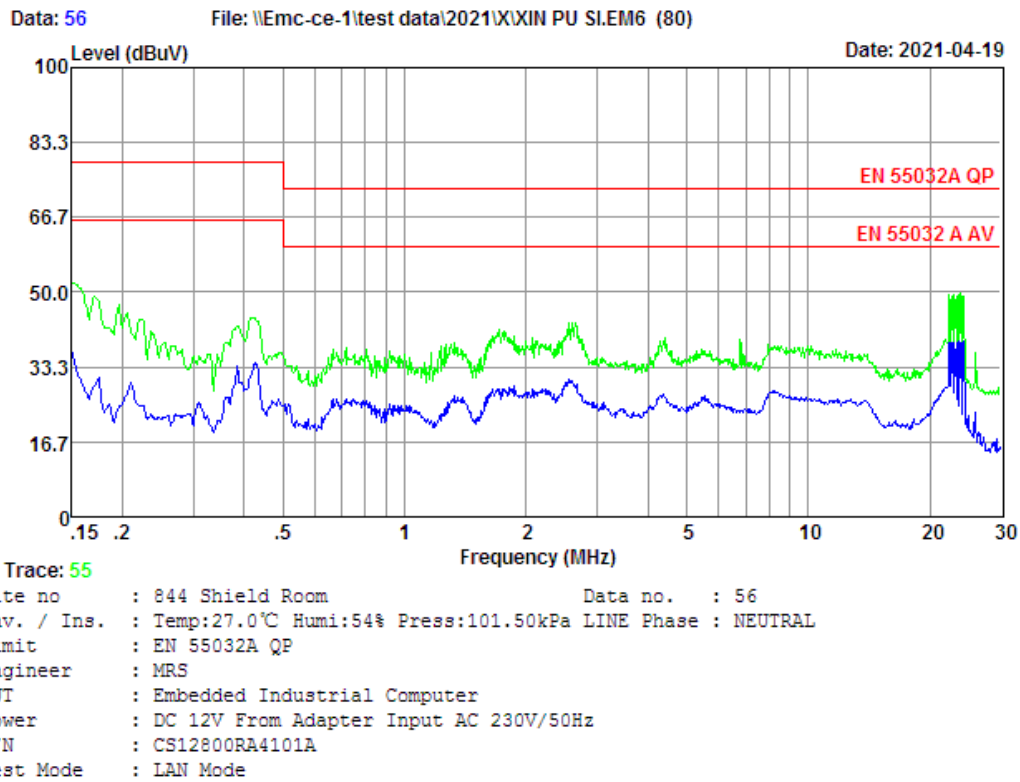
**Note: Test uncertainty:  $\pm 3.38\text{dB}$  at a level of confidence of 95%.(1#CE)**

## Test Data

EST Technology

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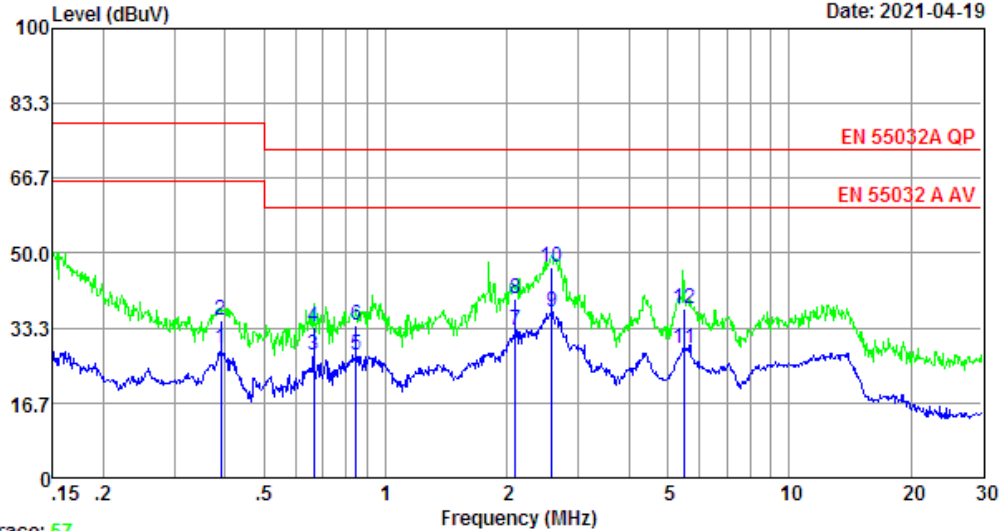




Data: 58

File: \\Emc-ce-1\test data\2021\X\XIN PU SLEM6 (80)

Date: 2021-04-19



Trace: 57

Site no : 844 Shield Room Data no. : 58  
 Env. / Ins. : Temp:27.0°C Humi:54% Press:101.50kPa LINE Phase : LINE  
 Limit : EN 55032A QP  
 Engineer : MRS  
 EUT : Embedded Industrial Computer  
 Power : DC 12V From Adapter Input AC 110V/60Hz  
 M/N : CS12800RA4101A  
 Test Mode : LAN Mode

	Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.39	9.84	9.92	9.10	28.86	66.00	37.14	Average
2	0.39	9.84	9.92	15.19	34.95	79.00	44.05	QP
3	0.66	9.82	9.92	7.49	27.23	60.00	32.77	Average
4	0.66	9.82	9.92	13.69	33.43	73.00	39.57	QP
5	0.84	9.80	9.93	7.63	27.36	60.00	32.64	Average
6	0.84	9.80	9.93	14.11	33.84	73.00	39.16	QP
7	2.10	9.81	9.96	13.21	32.98	60.00	27.02	Average
8	2.10	9.81	9.96	20.27	40.04	73.00	32.96	QP
9	2.58	9.84	9.97	17.14	36.95	60.00	23.05	Average
10	2.58	9.84	9.97	26.97	46.78	73.00	26.22	QP
11	5.48	9.86	10.01	8.98	28.85	60.00	31.15	Average
12	5.48	9.86	10.01	17.65	37.52	73.00	35.48	QP

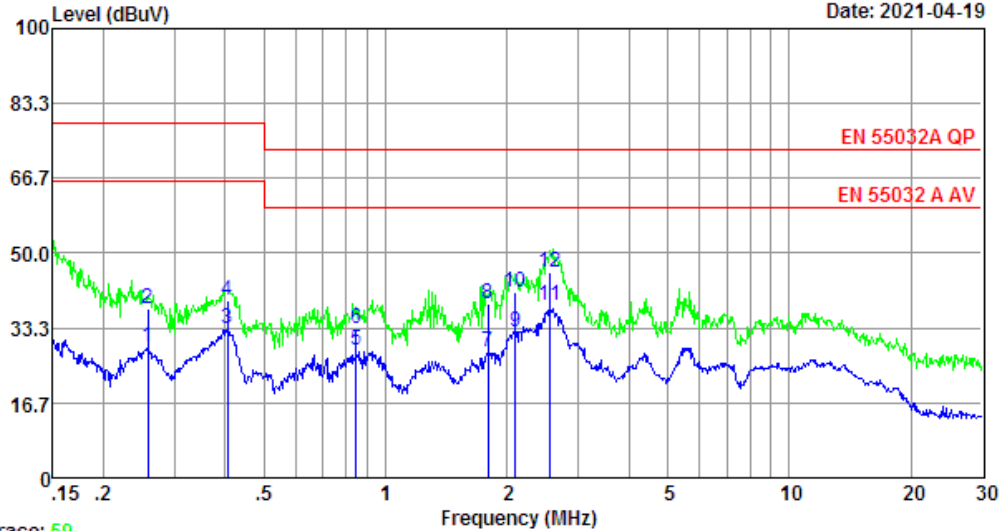
Remarks: 1. Emission Level= LISN Factor + Cable Loss + Reading.  
 2. Margin= Limit - Emission Level.  
 3. If the average limit is met when using a quasi-peak detector,  
 the EUT shall be deemed to meet both limits and measurement  
 with average detector is unnecessary.



Data: 60

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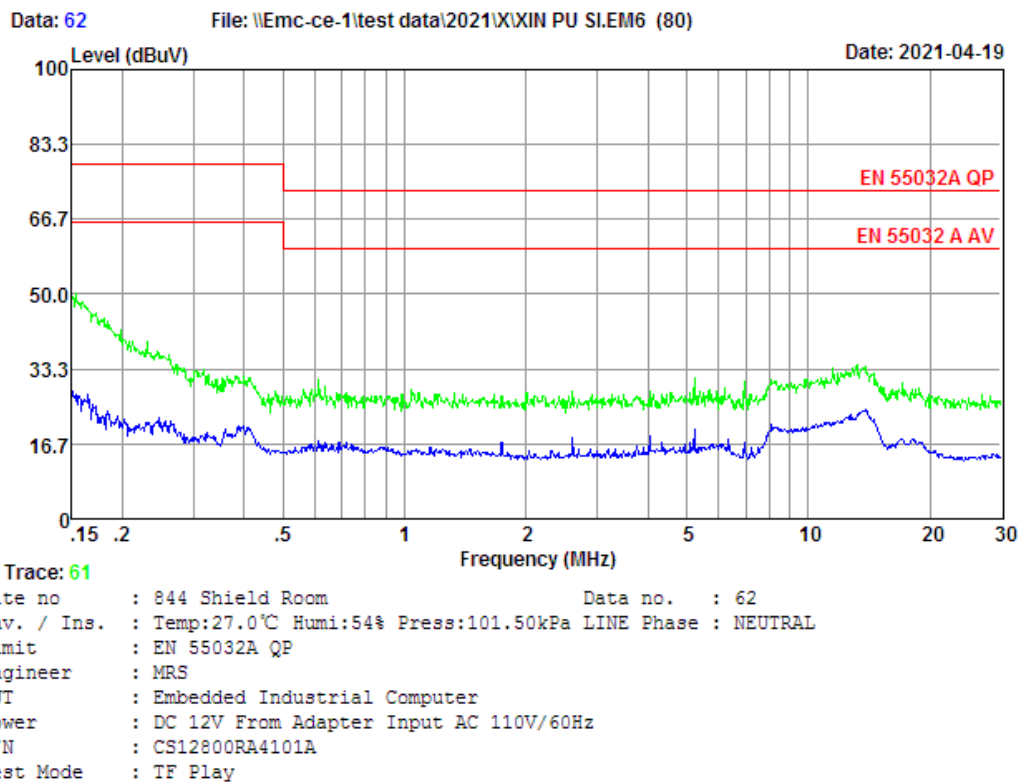
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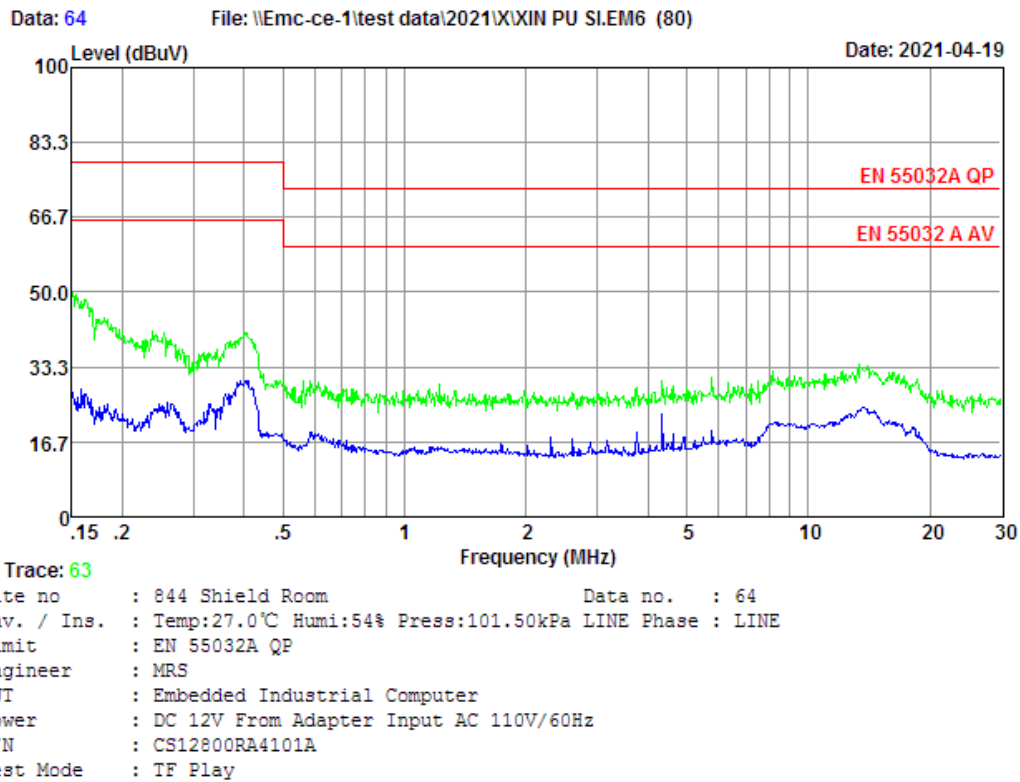


Trace: 59  
 Site no : 844 Shield Room Data no. : 60  
 Env. / Ins. : Temp:27.0°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL  
 Limit : EN 55032A QP  
 Engineer : MRS  
 EUT : Embedded Industrial Computer  
 Power : DC 12V From Adapter Input AC 110V/60Hz  
 M/N : CS12800RA4101A  
 Test Mode : LAN Mode

	Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.26	9.71	9.92	9.37	29.00	66.00	37.00	Average
2	0.26	9.71	9.92	18.17	37.80	79.00	41.20	QP
3	0.41	9.76	9.92	13.50	33.18	66.00	32.82	Average
4	0.41	9.76	9.92	19.98	39.66	79.00	39.34	QP
5	0.84	9.71	9.93	8.79	28.43	60.00	31.57	Average
6	0.84	9.71	9.93	13.62	33.26	73.00	39.74	QP
7	1.79	9.68	9.95	8.57	28.20	60.00	31.80	Average
8	1.79	9.68	9.95	19.28	38.91	73.00	34.09	QP
9	2.10	9.70	9.96	12.91	32.57	60.00	27.43	Average
10	2.10	9.70	9.96	21.79	41.45	73.00	31.55	QP
11	2.54	9.78	9.96	18.81	38.55	60.00	21.45	Average
12	2.54	9.78	9.96	26.20	45.94	73.00	27.06	QP

Remarks: 1. Emission Level= LISN Factor + Cable Loss + Reading.  
 2. Margin= Limit - Emission Level.  
 3. If the average limit is met when using a quasi-peak detector,  
 the EUT shall be deemed to meet both limits and measurement  
 with average detector is unnecessary.

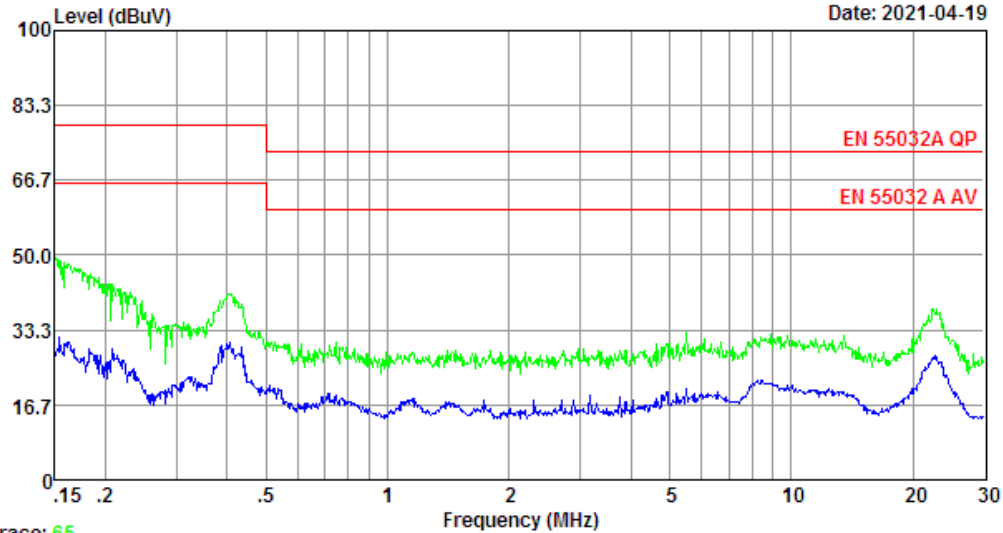




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Date: 2021-04-19

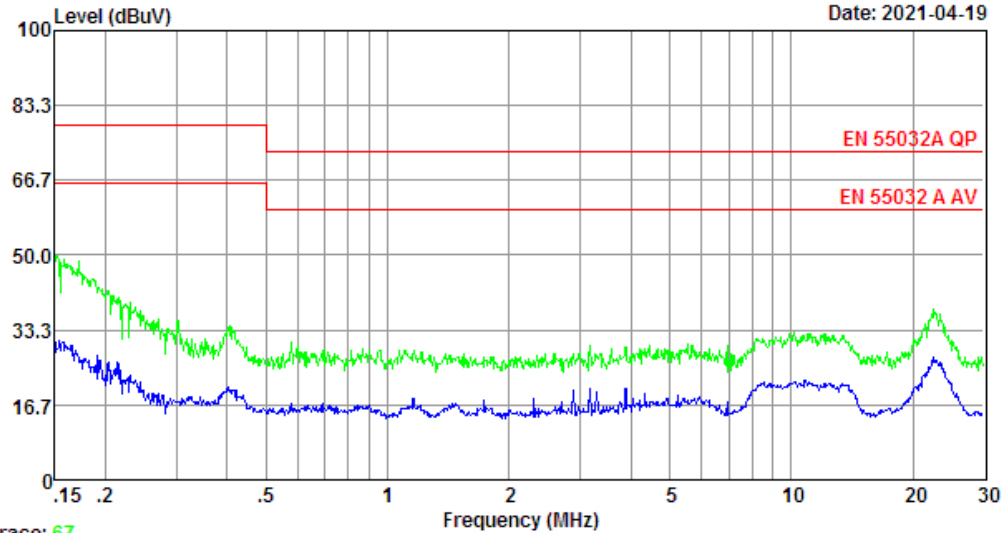


Site no : 844 Shield Room Data no. : 66  
Env. / Ins. : Temp:27.0°C Humi:54% Press:101.50kPa LINE Phase : LINE  
Limit : EN 55032A QP  
Engineer : MRS  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play

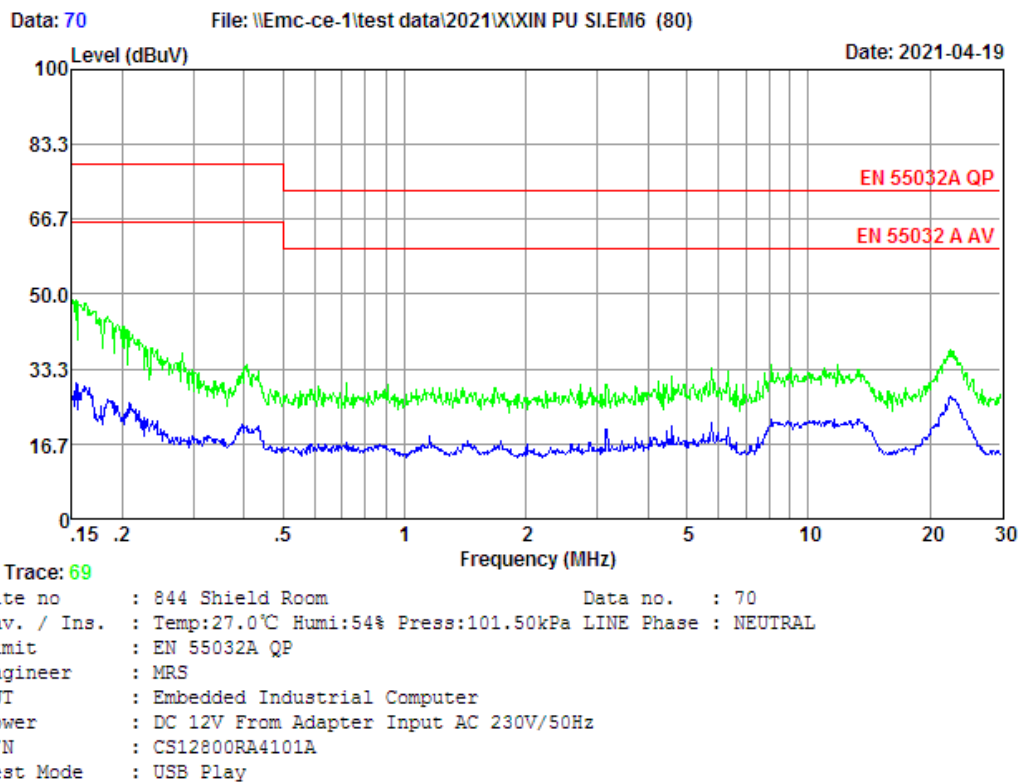
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File: \\Emc-ce-1\\test data\\2021\\X\\XIN PU SLEM6 (80)

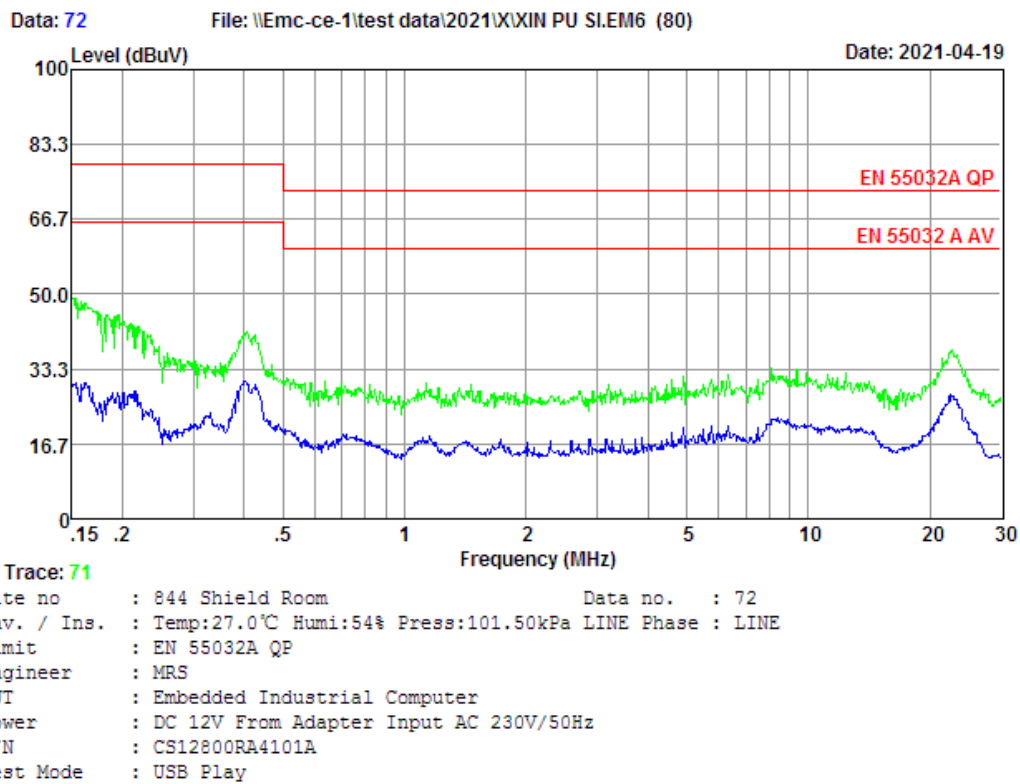
Date: 2021-04-19

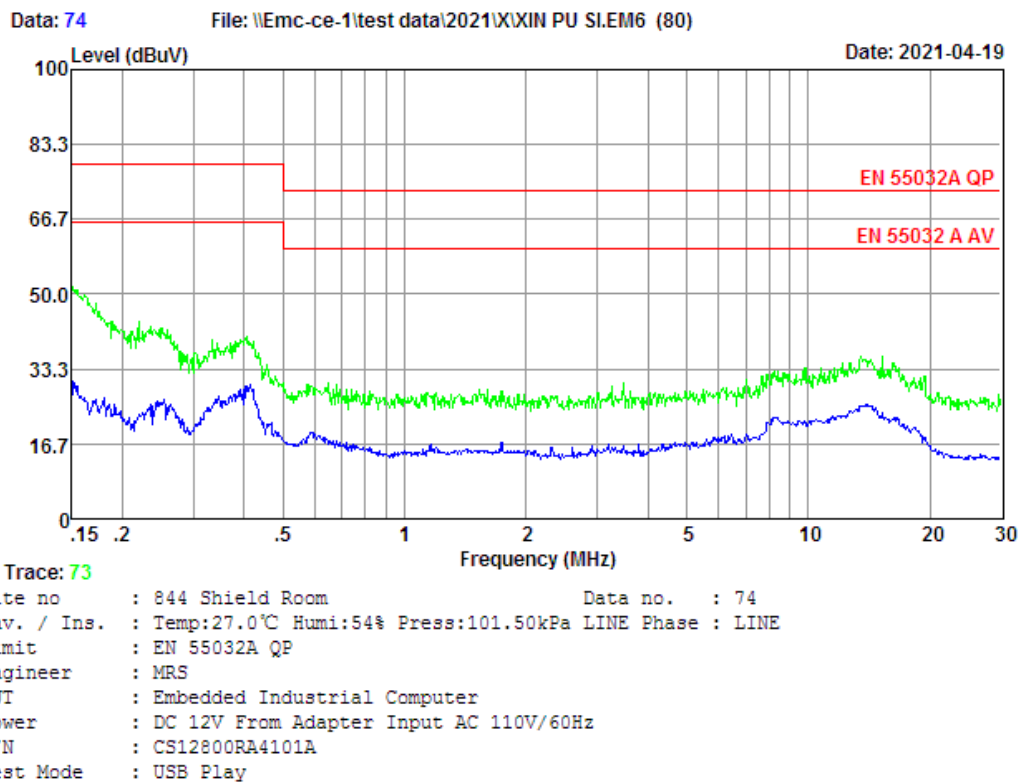


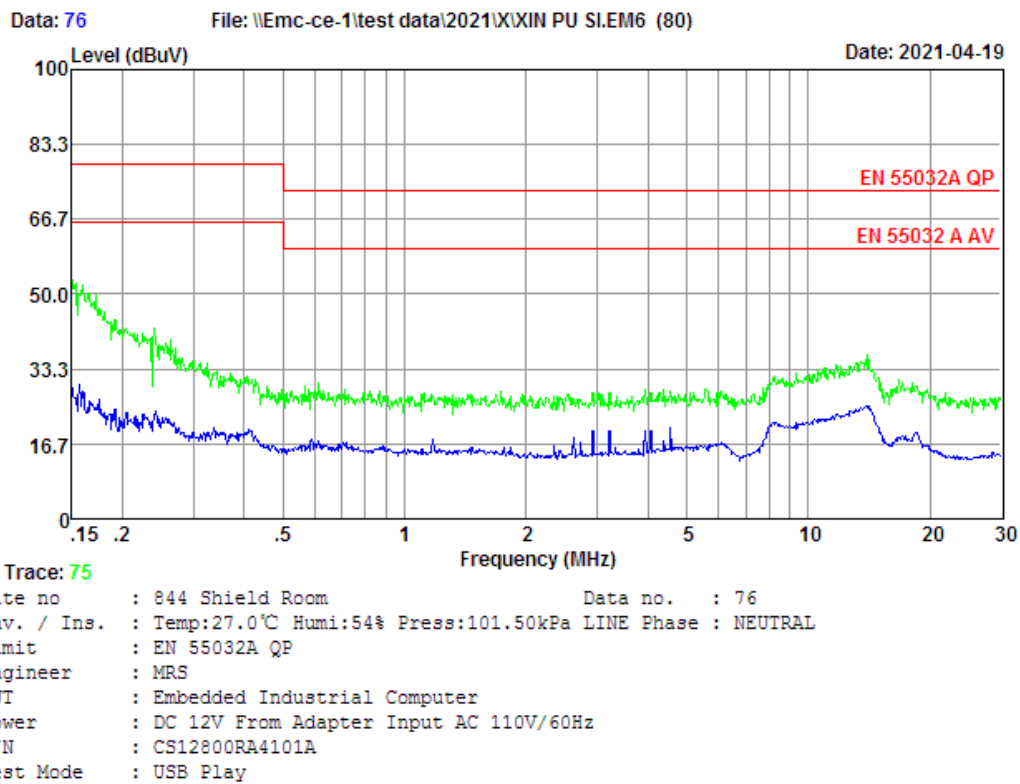
Site no : 844 Shield Room Data no. : 68  
Env. / Ins. : Temp:27.0°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL  
Limit : EN 55032A QP  
Engineer : MRS  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play











## 4.2. Asymmetric Mode Conducted Emissions Test

**RESULT : Pass**

Test procedure : EN 55032:2015+A11:2020

Frequency range : 0.15~30MHz

Test Site : Shielded Room

Limits : EN 55032:2015+A11:2020 Class A

### **Test Setup**

Date of test : Apr. 19, 2021

Model No. : CS12800RA4101A

Input Voltage : DC 12V From Adapter Input AC 230V/50Hz,  
DC 12V From Adapter Input AC 110V/60Hz

Operation Mode : LAN Mode

The frequency range from 150 kHz to 30 MHz was investigated.

The bandwidth of the test receiver was set at 9 kHz.

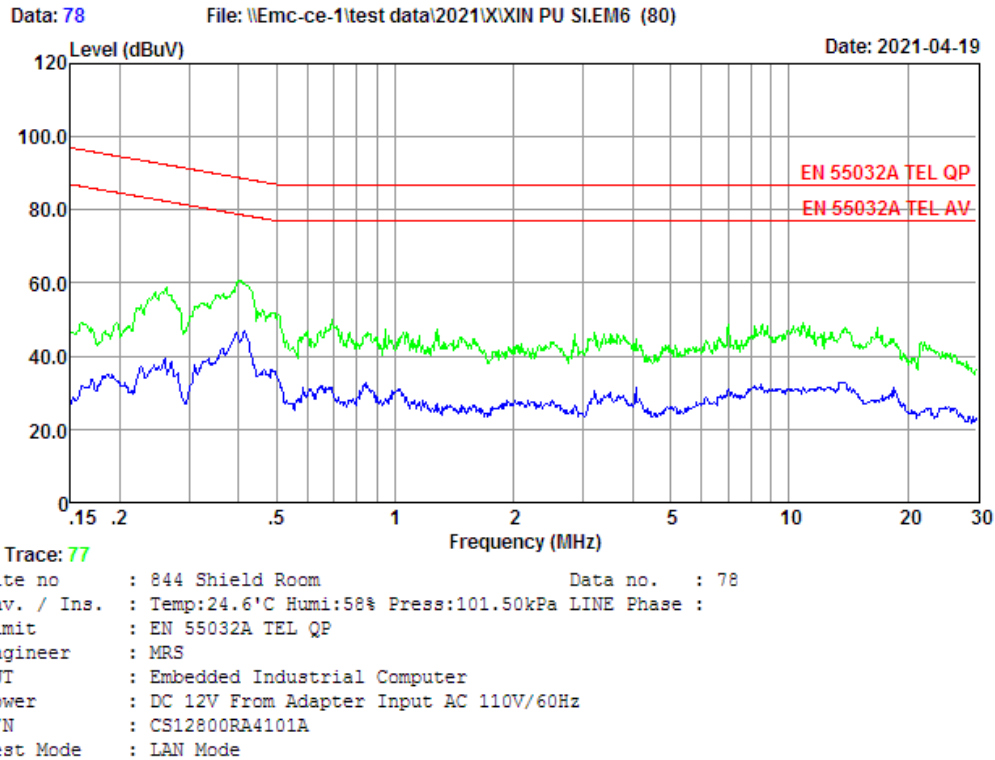
The test data of the worst case condition(s) was reported on the following page.

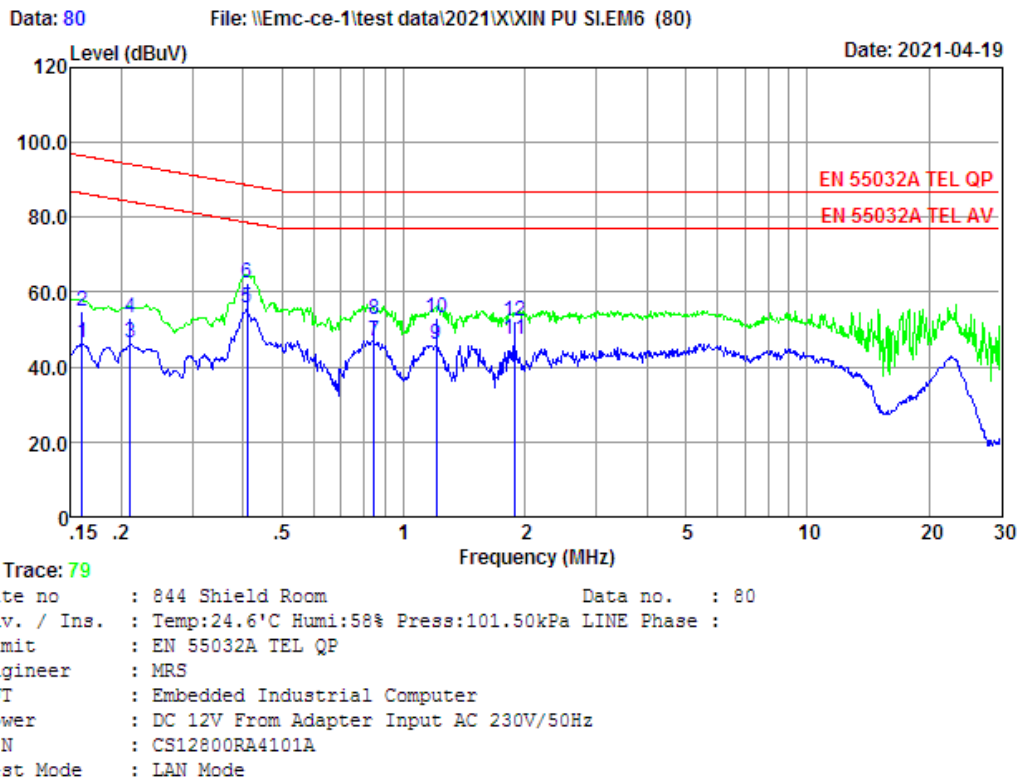
**Note: Test uncertainty:  $\pm 4.18\text{dB}$  at a level of confidence of 95%.**

## Test Data

EST Technology

Chilingxiang, Qishantou, Santun,  
Houjie, Dongguan, Guangdong, China  
Tel: +86-769-83081888  
Fax: +86-769-83081878





	Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.16	10.13	9.69	26.54	46.36	83.47	37.11	Average
2	0.16	10.13	9.69	34.98	54.80	96.47	41.67	QP
3	0.21	10.04	9.84	26.58	46.46	81.18	34.72	Average
4	0.21	10.04	9.84	33.29	53.17	94.18	41.01	QP
5	0.41	9.84	9.92	35.98	55.74	75.64	19.90	Average
6	0.41	9.84	9.92	42.55	62.31	88.64	26.33	QP
7	0.84	9.71	9.93	27.52	47.16	74.00	26.84	Average
8	0.84	9.71	9.93	33.21	52.85	87.00	34.15	QP
9	1.20	9.67	9.94	26.48	46.09	74.00	27.91	Average
10	1.20	9.67	9.94	33.62	53.23	87.00	33.77	QP
11	1.89	9.64	9.96	27.60	47.20	74.00	26.80	Average
12	1.89	9.64	9.96	32.78	52.38	87.00	34.62	QP

Remarks: 1. Emission Level= LISN Factor + Cable Loss + Reading.  
2. Margin= Limit - Emission Level.  
3. If the average limit is met when using a quasi-peak detector,  
the EUT shall be deemed to meet both limits and measurement  
with average detector is unnecessary.



### 4.3. Radiated Emission Test

**RESULT** : **Pass**  
Test procedure : EN 55032:2015+A11:2020  
Frequency range : 30~1000MHz  
Test Site : 2#966 Chamber  
Limits : EN 55032:2015+A11:2020 Class A

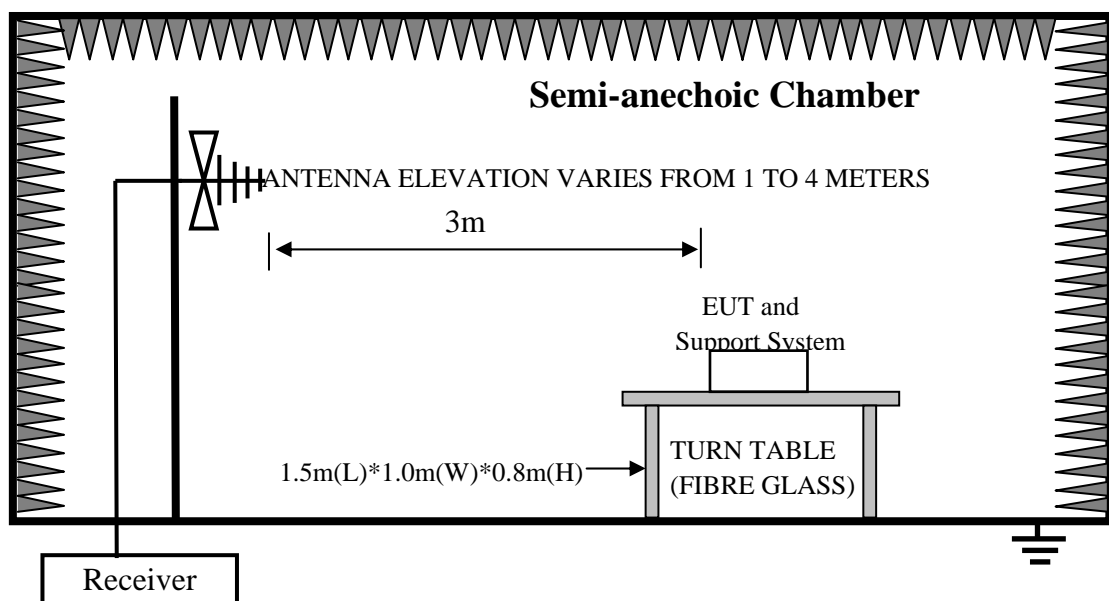
#### Test Setup

Date of test : Apr. 22, 2021  
Model No. : CS12800RA4101A  
Input Voltage : DC 12V From Adapter Input AC 230V/50Hz,  
DC 12V From Adapter Input AC 110V/60Hz  
Operation Mode : TF Play, USB Play, LAN Mode

The EUT was placed on a turn table which was 0.8 m above the ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT was set 3 m away from the receiving antenna which was mounted on an antenna tower. The measuring antenna moved up and down to find out the maximum emission level. It moved from 1 m to 4 m for both horizontal and vertical polarizations.

The EUT was tested in the Chamber Site. It was pre-scanned with a Peak detector from the spectrum, and all the final readings from the test receiver were measured with the Quasi-Peak detector.

The bandwidth setting on the test receiver was 120 kHz.



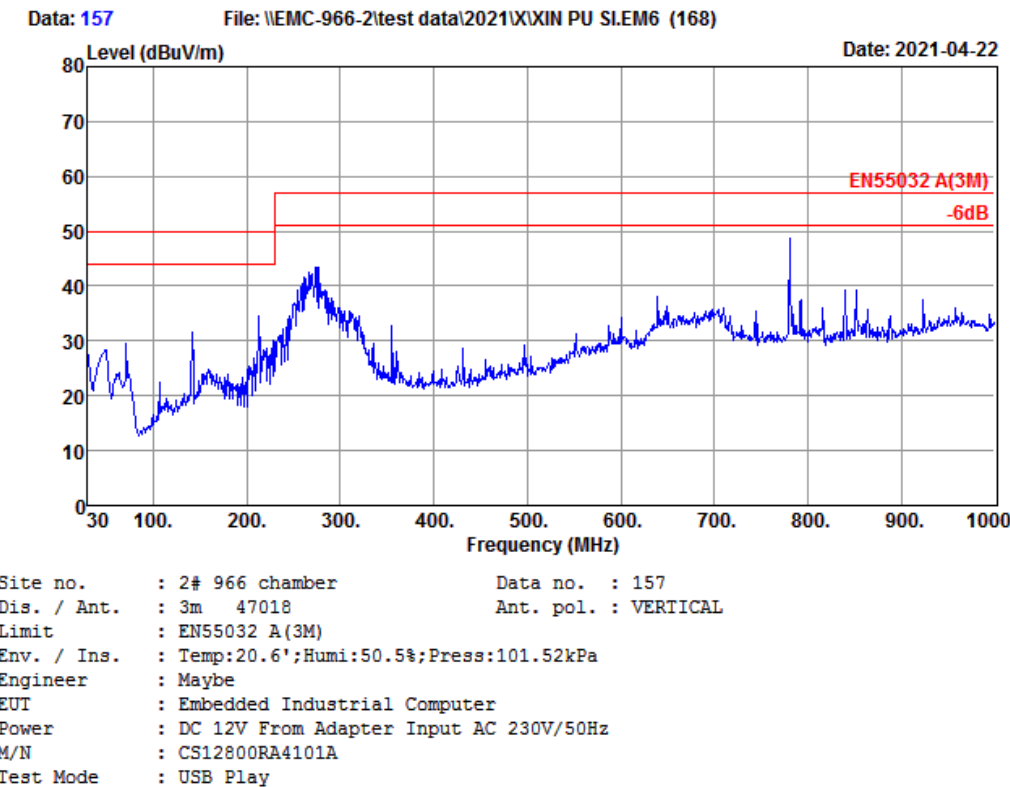
#### Note:

**Test uncertainty:  $\pm 4.26$  dB (H);  $\pm 4.74$  dB (V) at a level of confidence of 95%.(2#966)**

Test Data

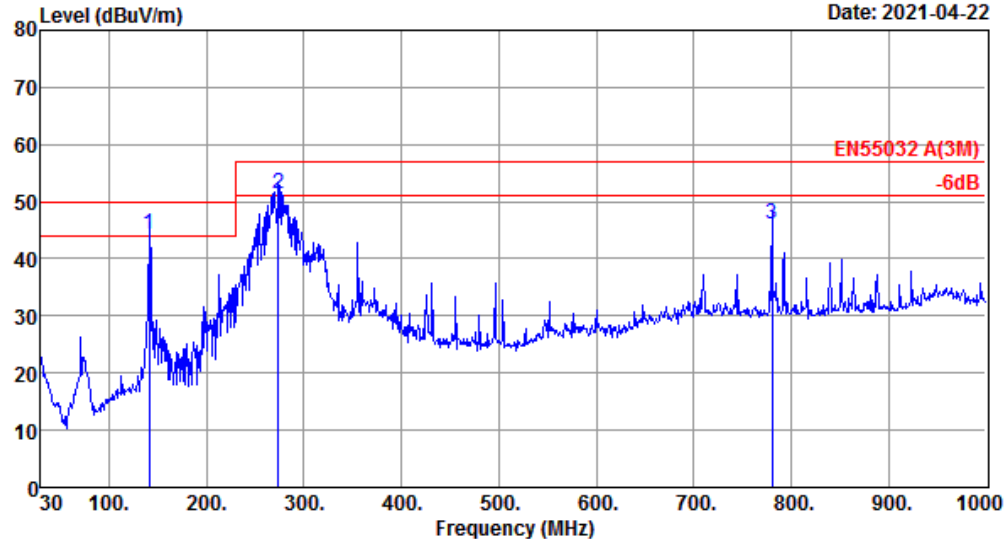
EST Technology

Chilingxiang, Qishantou, Santun,  
Houjie, Dongguan, Guangdong, China  
Tel:+86-769-83081888  
Fax:+86-769-83081878



Data: 158 File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22



Site no. : 2# 966 chamber Data no. : 158  
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : USB Play

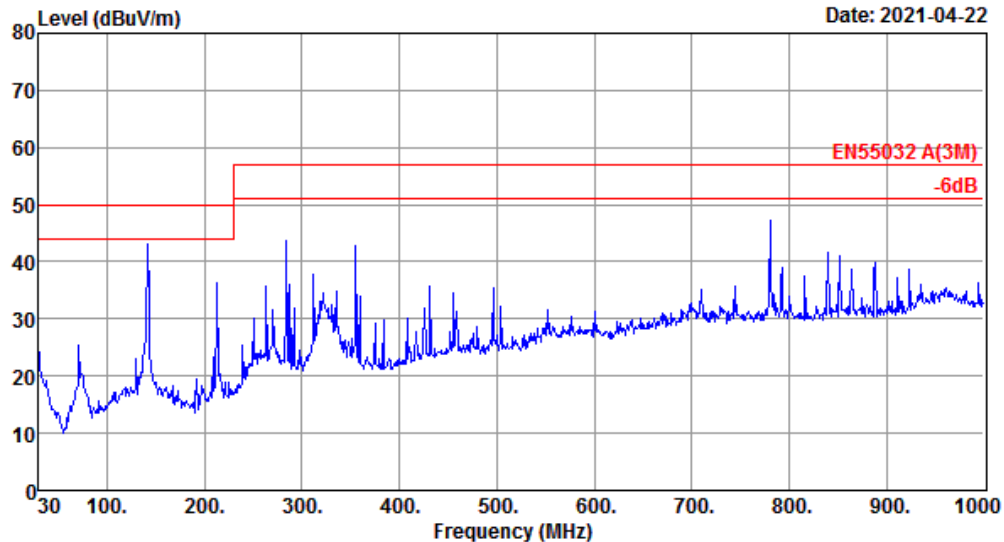
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	141.55	11.33	0.97	32.02	44.32	50.00	5.68	QP
2	273.47	12.50	1.53	37.35	51.38	57.00	5.62	QP
3	780.78	22.38	2.94	20.70	46.02	57.00	10.98	QP

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.  
2. Margin= Limit - Emission Level.  
3. The emission levels that are 20dB below the official limit are not reported.

Data: 159

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22

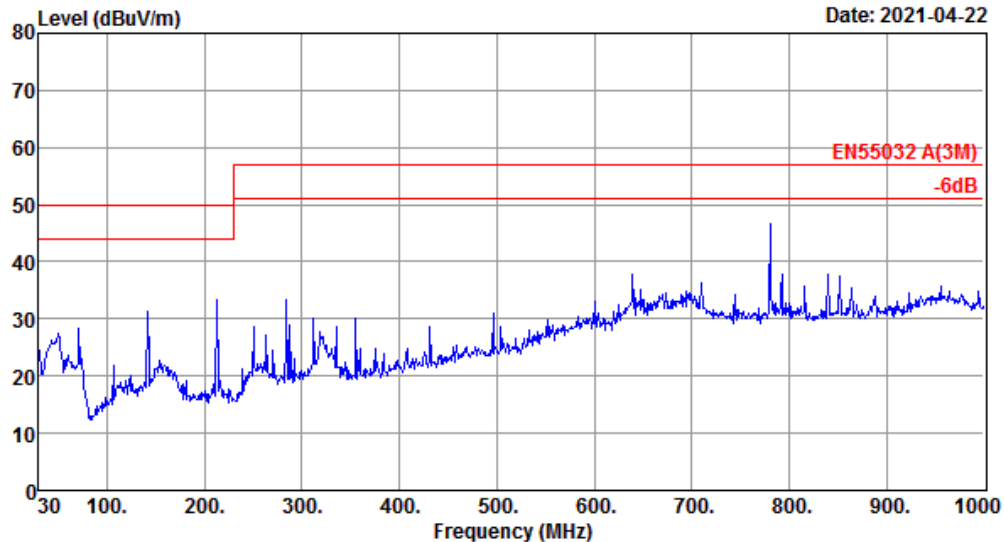


Site no. : 2# 966 chamber Data no. : 159  
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play

Data: 160

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22

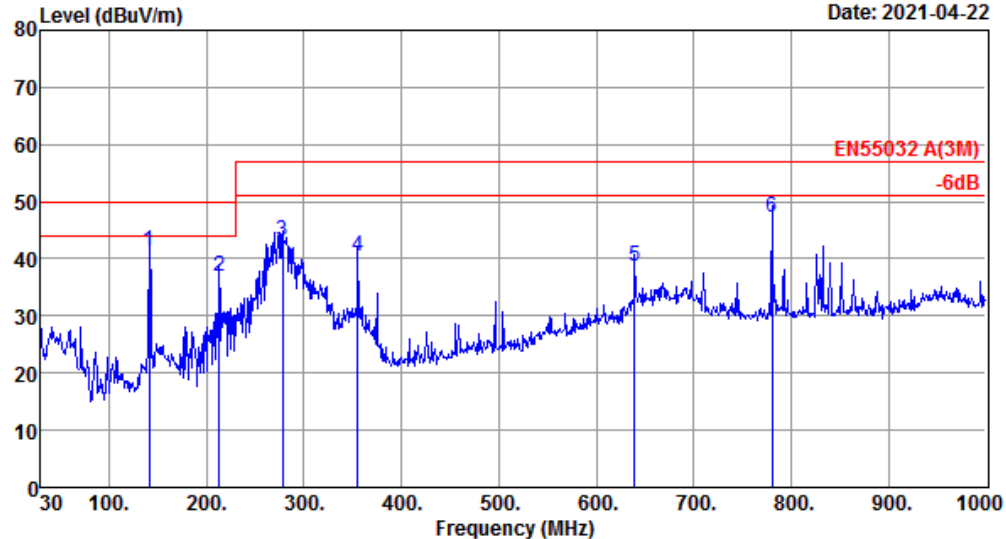


Site no. : 2# 966 chamber Data no. : 160  
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play

Data: 161

File: \\EMC-966-2\\test data\\2021\\XIN PU SLEM6 (168)

Date: 2021-04-22



Site no. : 2# 966 chamber Data no. : 161  
 Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL  
 Limit : EN55032 A(3M)  
 Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
 Engineer : Maybe  
 EUT : Embedded Industrial Computer  
 Power : DC 12V From Adapter Input AC 230V/50Hz  
 M/N : CS12800RA4101A  
 Test Mode : LAN Mode

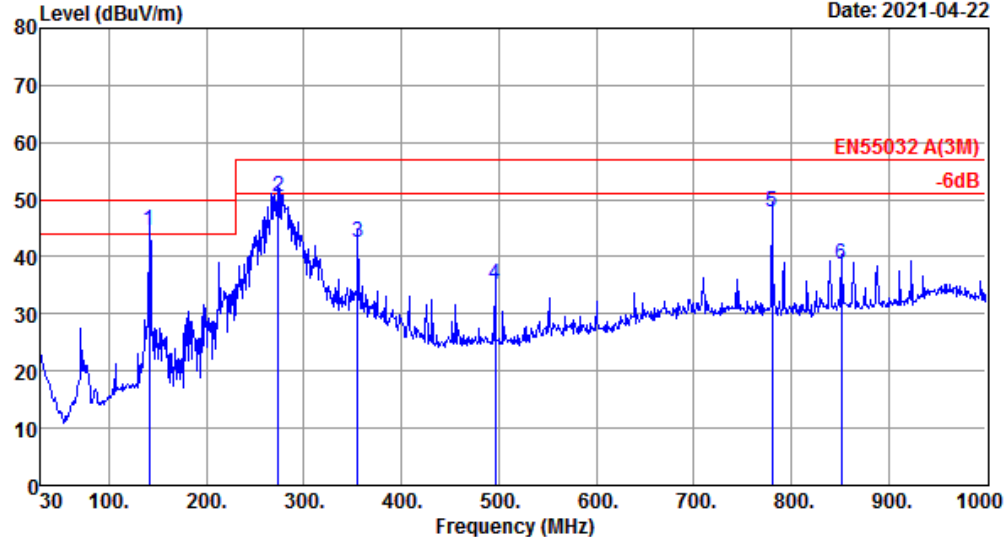
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	141.55	11.33	0.97	28.99	41.29	50.00	8.71	QP
2	213.33	8.63	1.21	27.16	37.00	50.00	13.00	QP
3	278.32	12.47	1.55	28.95	42.97	57.00	14.03	QP
4	354.95	14.45	1.84	24.04	40.33	57.00	16.67	QP
5	639.16	20.34	2.71	15.68	38.73	57.00	18.27	QP
6	780.78	22.38	2.94	21.87	47.19	57.00	9.81	QP

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.  
 2. Margin= Limit - Emission Level.  
 3. The emission levels that are 20dB below the official limit are not reported.



Data: 162 File: \\EMC-966-2\\test data\\2021\\X\\XIN PU S\\EM6 (168)

Date: 2021-04-22



Site no. : 2# 966 chamber Data no. : 162  
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°; Humi:50.5%; Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : LAN Mode

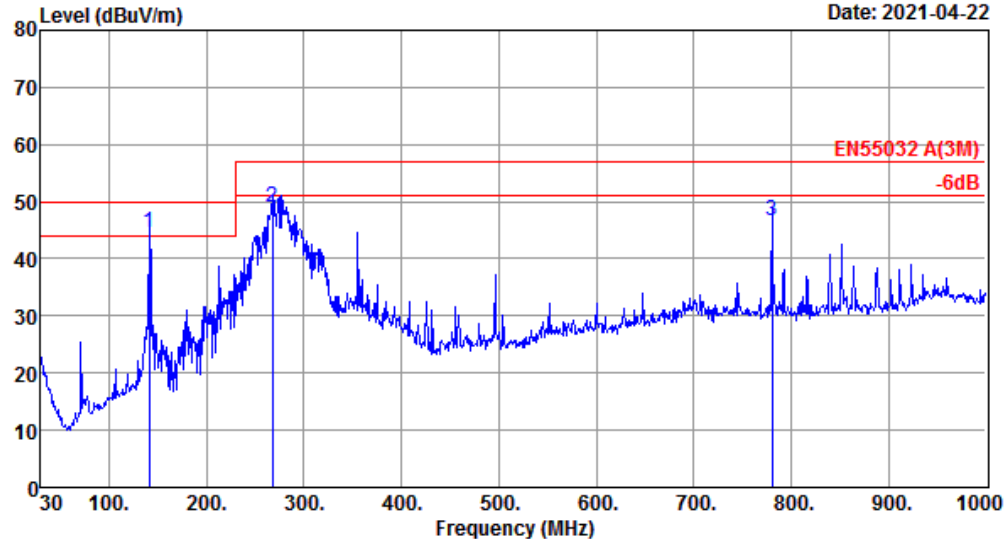
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	141.55	11.33	0.97	32.36	44.66	50.00	5.34	QP
2	273.47	12.50	1.53	36.34	50.37	57.00	6.63	QP
3	354.95	14.45	1.84	26.33	42.62	57.00	14.38	QP
4	496.57	17.80	2.28	15.10	35.18	57.00	21.82	QP
5	780.78	22.38	2.94	22.38	47.70	57.00	9.30	QP
6	851.59	23.32	3.16	12.09	38.57	57.00	18.43	QP

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.  
2. Margin= Limit - Emission Level.  
3. The emission levels that are 20dB below the official limit are not reported.

Data: 163

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22



Site no. : 2# 966 chamber Data no. : 163  
 Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL  
 Limit : EN55032 A(3M)  
 Env. / Ins. : Temp:20.6°; Humi:50.5%; Press:101.52kPa  
 Engineer : Maybe  
 EUT : Embedded Industrial Computer  
 Power : DC 12V From Adapter Input AC 110V/60Hz  
 M/N : CS12800RA4101A  
 Test Mode : LAN Mode

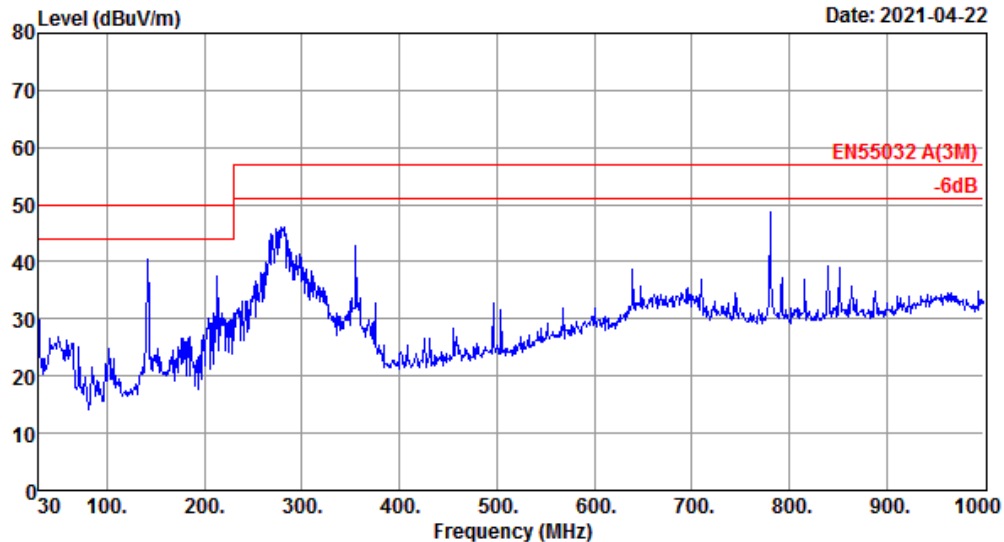
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	141.55	11.33	0.97	32.25	44.55	50.00	5.45	QP
2	267.65	12.63	1.50	34.97	49.10	57.00	7.90	QP
3	780.78	22.38	2.94	21.46	46.78	57.00	10.22	QP

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.  
 2. Margin= Limit - Emission Level.  
 3. The emission levels that are 20dB below the official limit are not reported.

Data: 164

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22

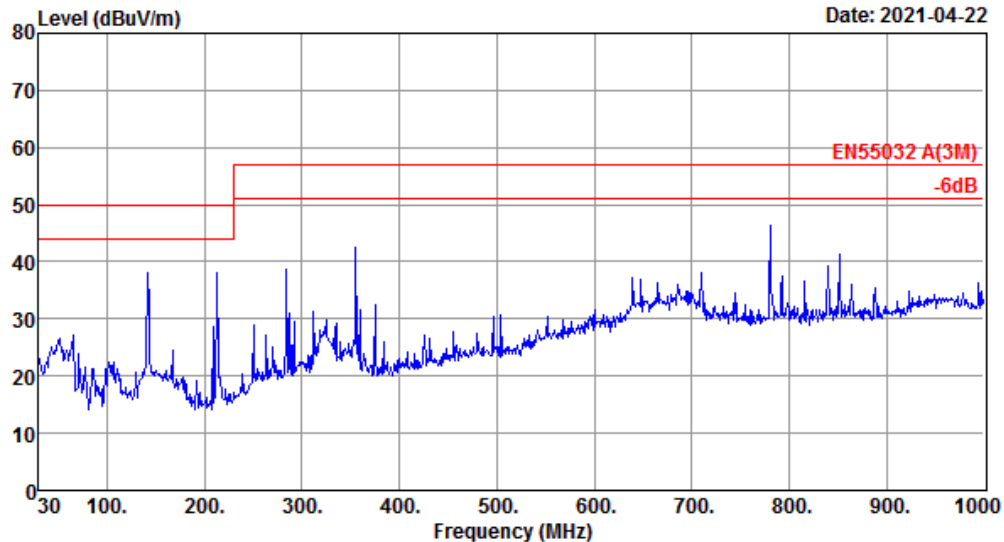


Site no. : 2# 966 chamber Data no. : 164  
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : LAN Mode

Data: 165

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22

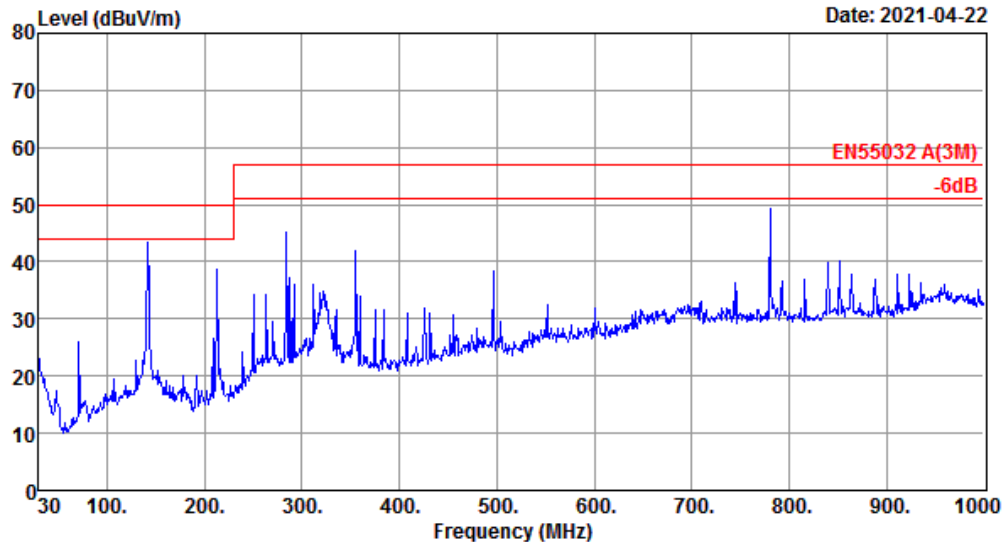


Site no. : 2# 966 chamber Data no. : 165  
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play

Data: 166

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22

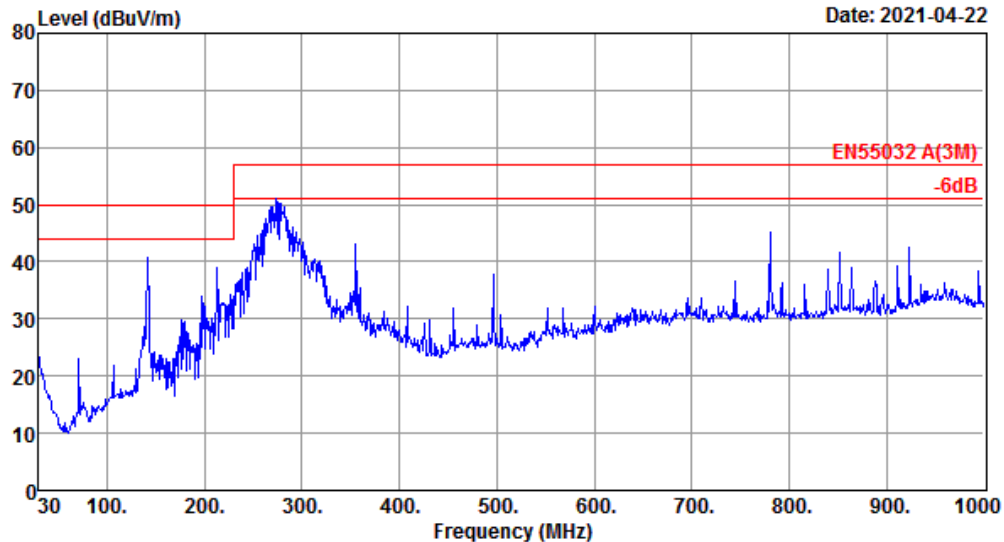


Site no. : 2# 966 chamber Data no. : 166  
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play

Data: 167

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SIEM6 (168)

Date: 2021-04-22

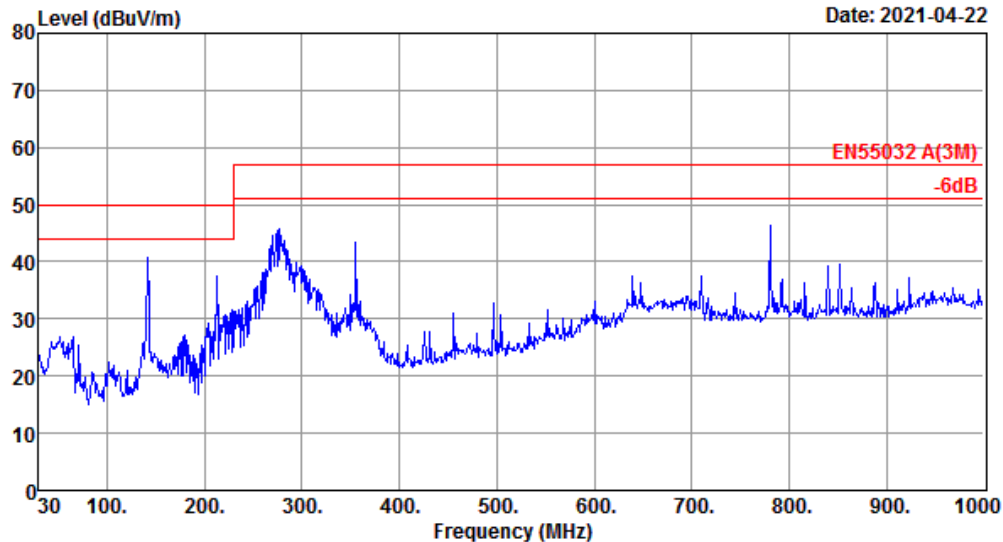


Site no. : 2# 966 chamber Data no. : 167  
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : USB Play

Data: 168

File: \\EMC-966-2\\test data\\2021\\X\\XIN PU SLEM6 (168)

Date: 2021-04-22



Site no. : 2# 966 chamber Data no. : 168  
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL  
Limit : EN55032 A(3M)  
Env. / Ins. : Temp:20.6°;Humi:50.5%;Press:101.52kPa  
Engineer : Maybe  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : USB Play

#### 4.4. Radiated Emission Test (above 1GHz)

**RESULT** : **Pass**  
Test procedure : EN 55032:2015+A11:2020  
Frequency range : 1GHz-6GHz  
Test Site : 966 Chamber  
Limits : EN 55032:2015+A11:2020 Class B

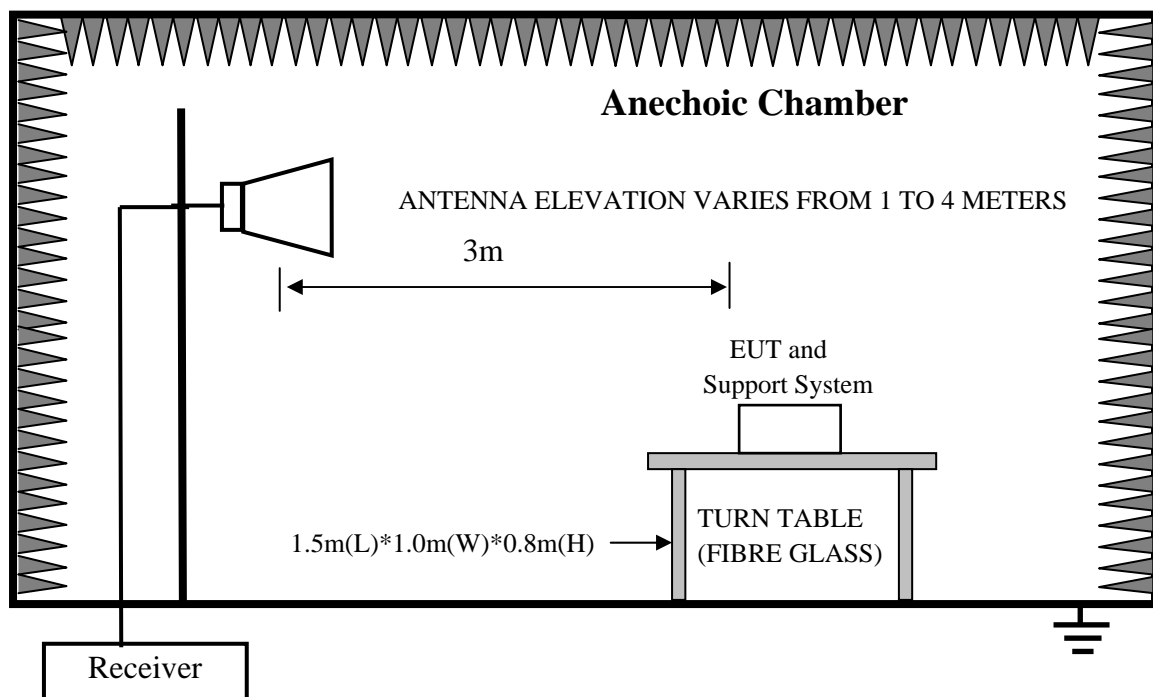
##### Test Setup

Date of test : Apr. 19, 2021  
Model No. : CS12800RA4101A  
Input Voltage : DC 12V From Adapter Input AC 230V/50Hz,  
DC 12V From Adapter Input AC 110V/60Hz  
Operation Mode : TF Play, USB Play, LAN Mode

The EUT was placed on a turn table which was 0.8 m above the ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT was set 3 m away from the receiving antenna which was mounted on an antenna tower. The measuring antenna moved up and down to find out the maximum emission level. It moved from 1 m to 4 m for both horizontal and vertical polarizations.

The EUT was tested in the Chamber Site. It was pre-scanned with a Peak detector and Average detector from the spectrum, and all the final readings from the test receiver were measured with the Peak detector and Average detector.

The bandwidth setting on the test receiver was 1MHz(above 1GHz).



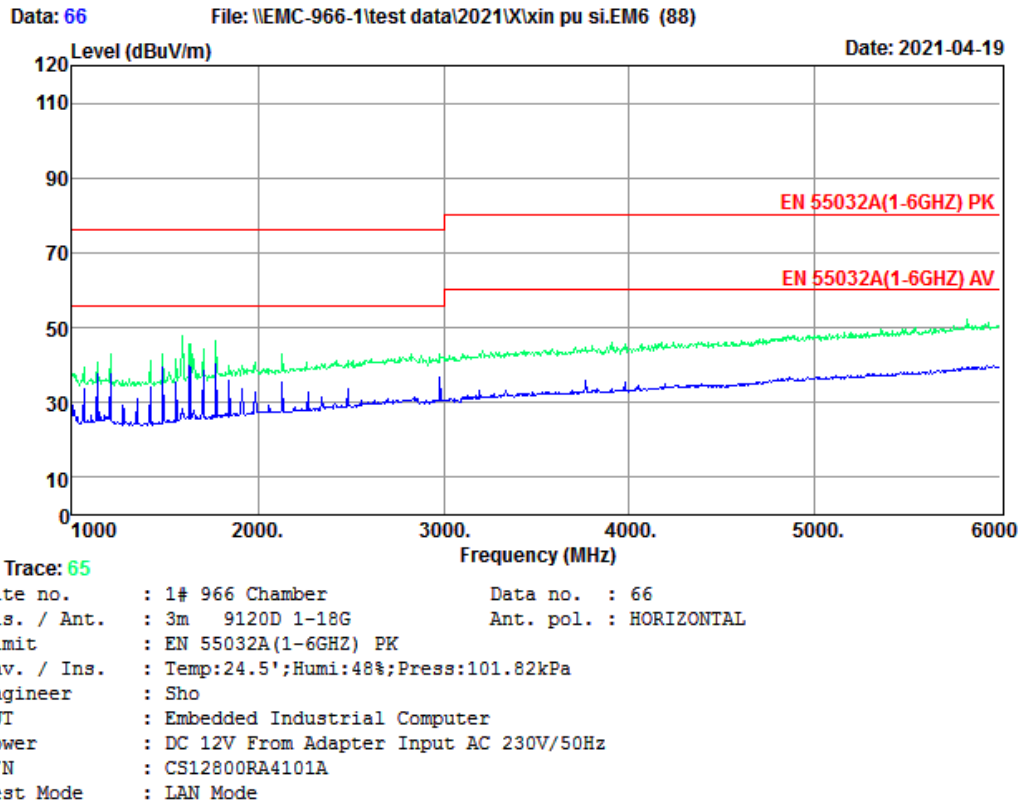
**Note: Test uncertainty:  $\pm 4.72\text{dB}$  at a level of confidence of 95%.**



## Test Data

EST Technology

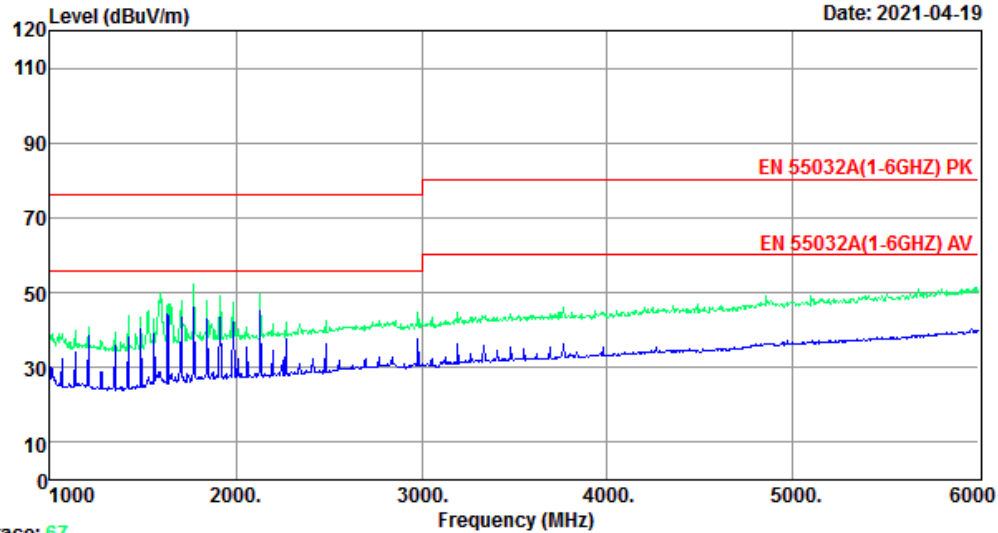
Chilingxiang, Qishantou, Santun,  
Houjie, Dongguan, Guangdong, China  
Tel: +86-769-83081888  
Fax: +86-769-83081878



Data: 68

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19



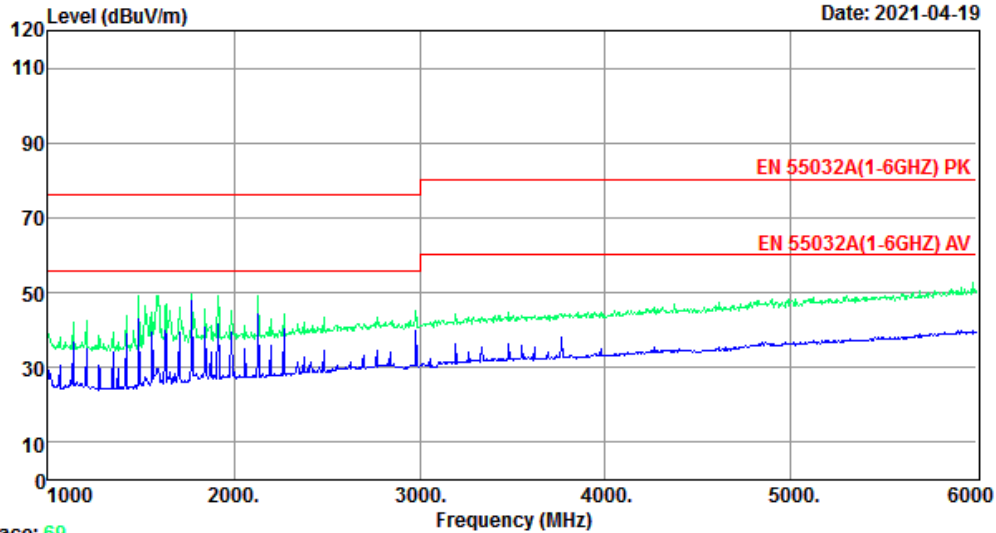
Trace: 67

Site no. : 1# 966 Chamber Data no. : 68  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : LAN Mode

Data: 70

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19

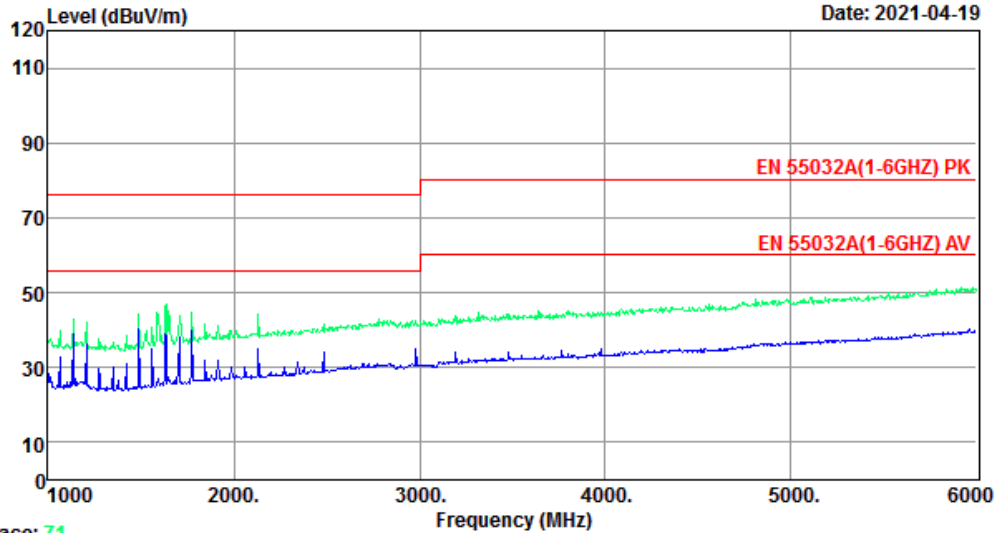


Trace: 69  
Site no. : 1# 966 Chamber Data no. : 70  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : USB Play

Data: 72

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19



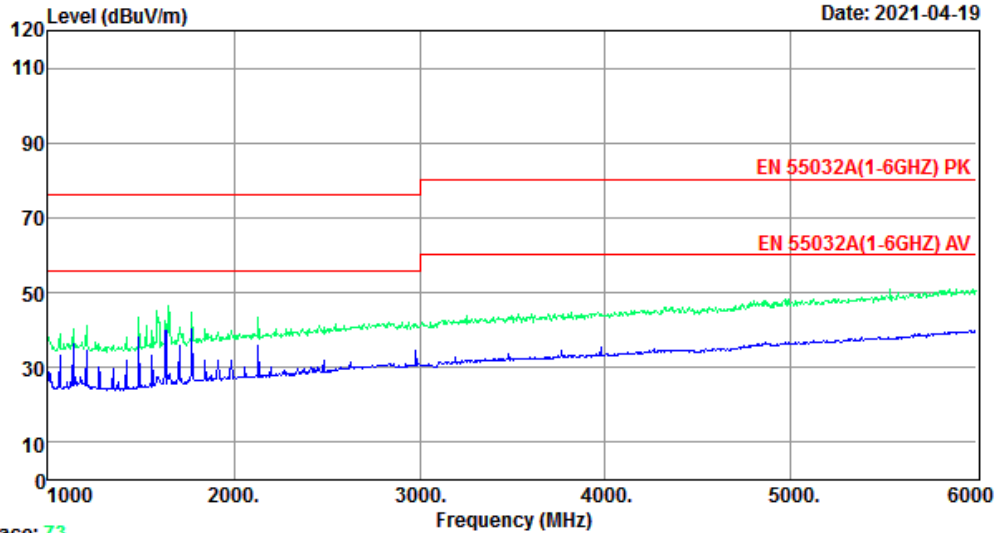
Trace: 71

Site no. : 1# 966 Chamber Data no. : 72  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : USB Play

Data: 74

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19



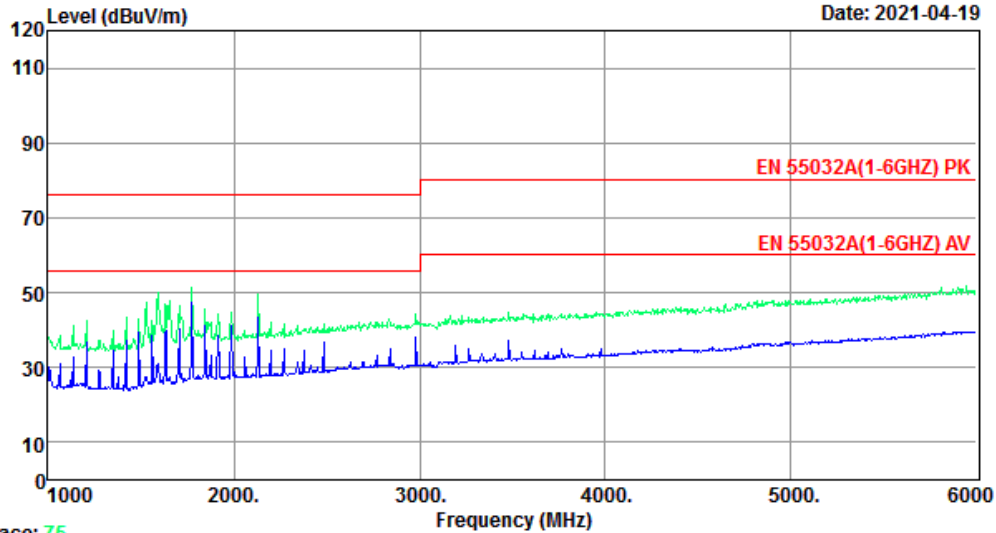
Trace: 73

Site no. : 1# 966 Chamber Data no. : 74  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play

Data: 76

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19



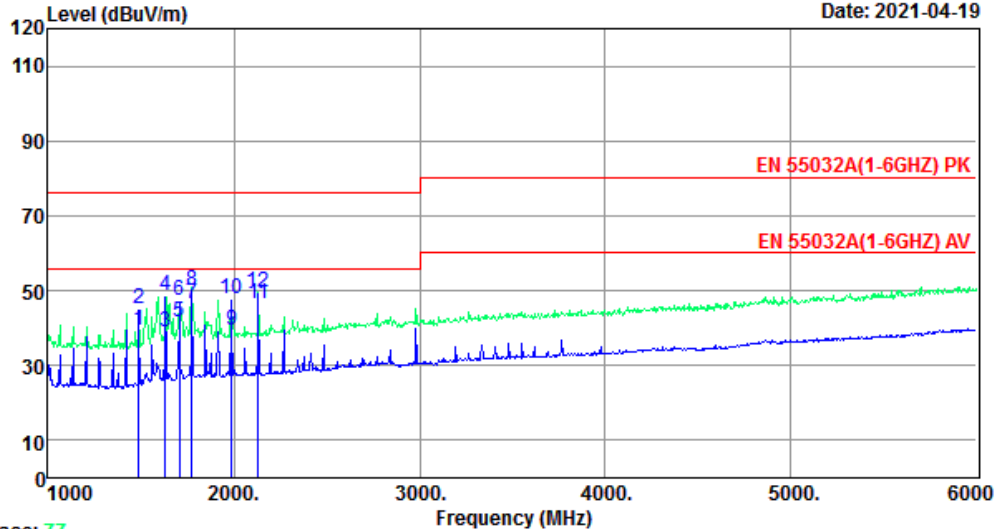
Trace: 75

Site no. : 1# 966 Chamber Data no. : 76  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 230V/50Hz  
M/N : CS12800RA4101A  
Test Mode : TF Play

Data: 78

File: \\EMC-966-1\test data\2021\X\xin pu si.EM6 (88)

Date: 2021-04-19



Trace: 77

Site no. : 1# 966 Chamber Data no. : 78  
 Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL  
 Limit : EN 55032A(1-6GHZ) PK  
 Env. / Ins. : Temp:24.5'; Humi:48%; Press:101.82kPa  
 Engineer : Sho  
 EUT : Embedded Industrial Computer  
 Power : DC 12V From Adapter Input AC 110V/60Hz  
 M/N : CS12800RA4101A  
 Test Mode : TF Play

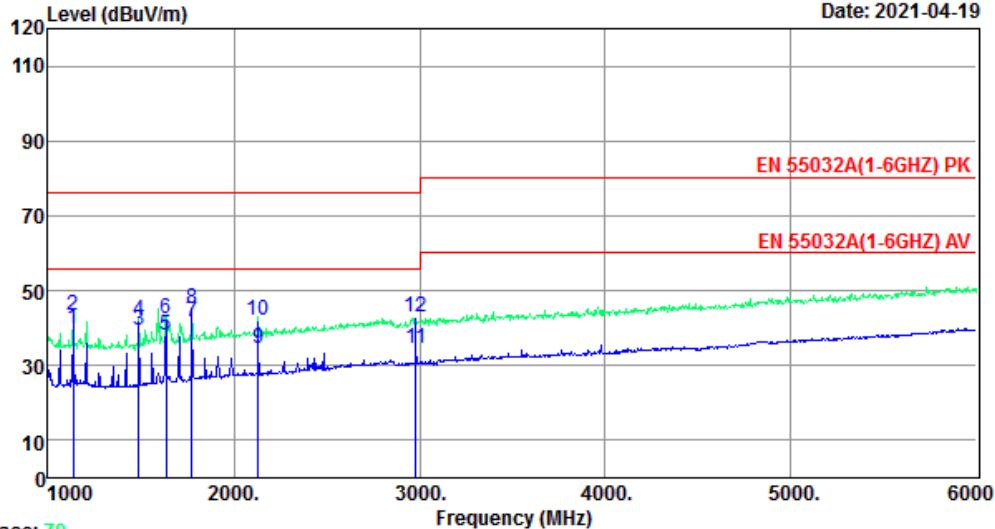
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	1490.00	24.82	1.14	13.66	39.62	56.00	16.38	Average
2	1490.00	24.82	1.14	19.20	45.16	76.00	30.84	Peak
3	1630.00	25.30	1.18	12.66	39.14	56.00	16.86	Average
4	1630.00	25.30	1.18	22.19	48.67	76.00	27.33	Peak
5	1705.00	25.50	1.20	14.87	41.57	56.00	14.43	Average
6	1705.00	25.50	1.20	20.79	47.49	76.00	28.51	Peak
7	1775.00	25.75	1.23	19.34	46.32	56.00	9.68	Average
8	1775.00	25.75	1.23	22.89	49.87	76.00	26.13	Peak
9	1990.00	26.62	1.28	11.57	39.47	56.00	16.53	Average
10	1990.00	26.62	1.28	19.77	47.67	76.00	28.33	Peak
11	2130.00	26.87	1.34	18.41	46.62	56.00	9.38	Average
12	2130.00	26.87	1.34	21.18	49.39	76.00	26.61	Peak

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.  
 2. Margin= Limit - Emission Level.  
 3. The emission levels that are 20dB below the official limit are not reported.

Data: 80

File: \\EMC-966-1\test data\2021\X\in pu si.EM6 (88)

Date: 2021-04-19



Trace: 79

Site no. : 1# 966 Chamber Data no. : 80  
 Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL  
 Limit : EN 55032A(1-6GHZ) PK  
 Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
 Engineer : Sho  
 EUT : Embedded Industrial Computer  
 Power : DC 12V From Adapter Input AC 110V/60Hz  
 M/N : CS12800RA4101A  
 Test Mode : TF Play

	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	1135.00	24.63	1.07	14.12	39.82	56.00	16.18	Average
2	1135.00	24.63	1.07	17.90	43.60	76.00	32.40	Peak
3	1490.00	24.82	1.14	13.46	39.42	56.00	16.58	Average
4	1490.00	24.82	1.14	16.18	42.14	76.00	33.86	Peak
5	1635.00	25.30	1.18	11.40	37.88	56.00	18.12	Average
6	1635.00	25.30	1.18	16.18	42.66	76.00	33.34	Peak
7	1775.00	25.75	1.23	14.46	41.44	56.00	14.56	Average
8	1775.00	25.75	1.23	17.96	44.94	76.00	31.06	Peak
9	2130.00	26.87	1.34	6.46	34.67	56.00	21.33	Average
10	2130.00	26.87	1.34	13.96	42.17	76.00	33.83	Peak
11	2980.00	28.52	2.14	4.01	34.67	56.00	21.33	Average
12	2980.00	28.52	2.14	12.17	42.83	76.00	33.17	Peak

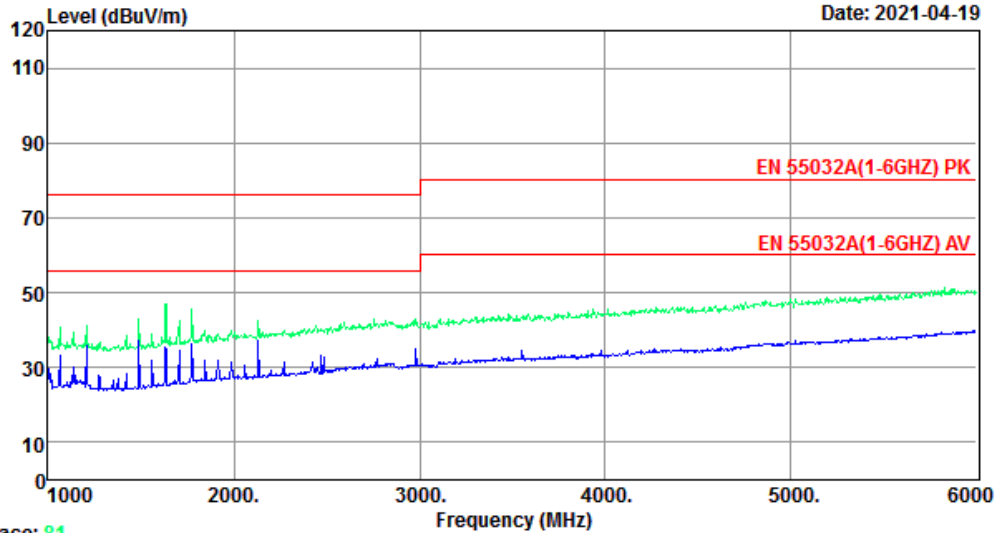
Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.  
 2. Margin= Limit - Emission Level.  
 3. The emission levels that are 20dB below the official limit are not reported.



Data: 82

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19



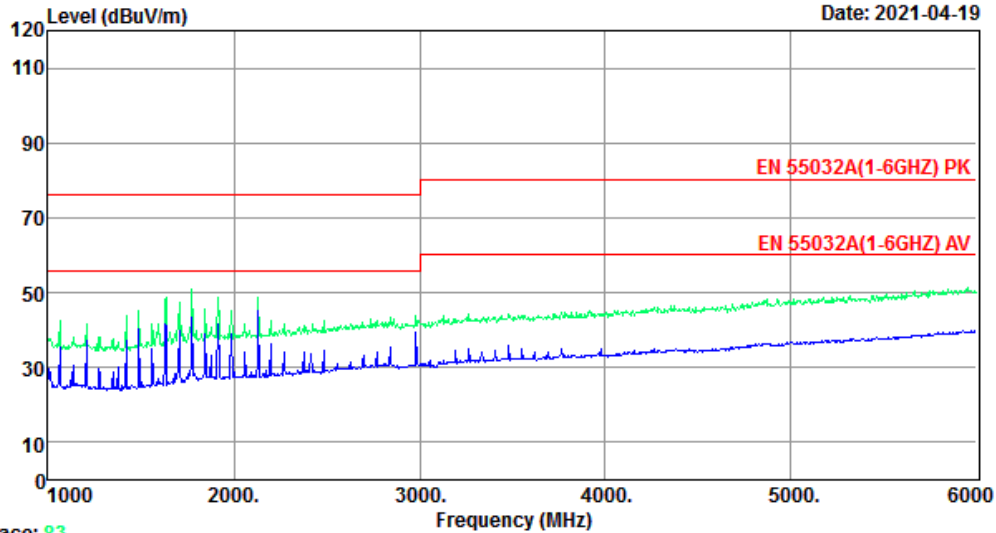
Trace: 81

Site no. : 1# 966 Chamber Data no. : 82  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : USB Play

Data: 84

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19



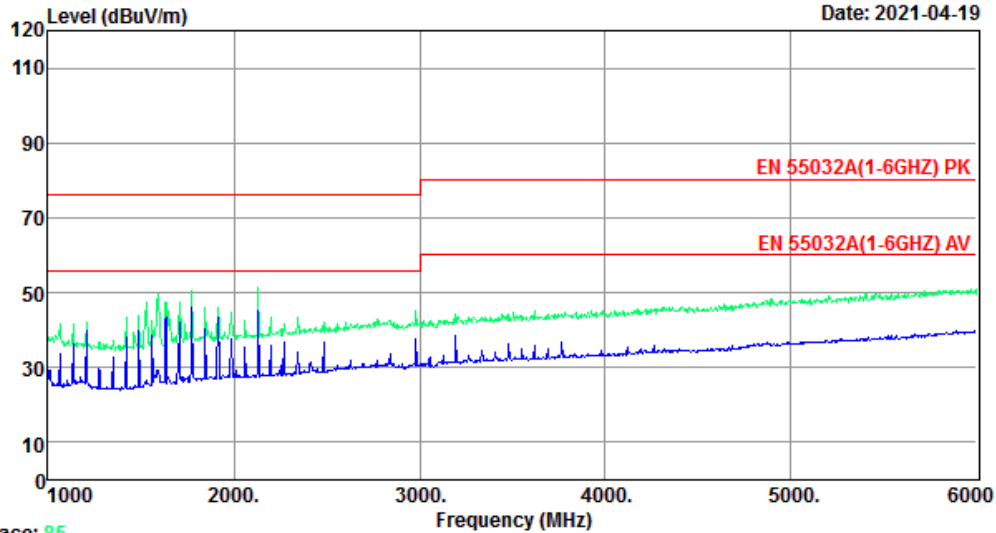
Trace: 83

Site no. : 1# 966 Chamber Data no. : 84  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : USB Play

Data: 86

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (88)

Date: 2021-04-19

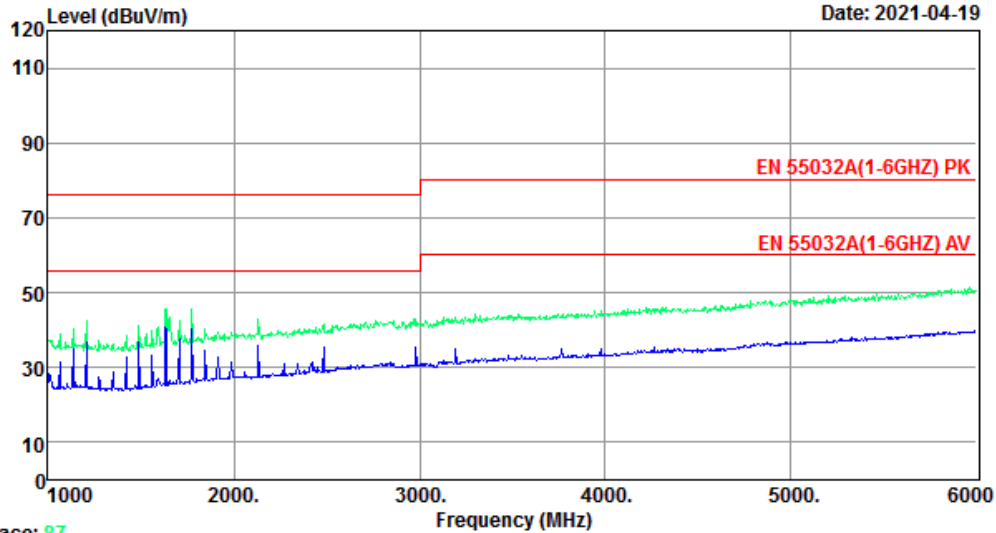


Trace: 85

Site no. : 1# 966 Chamber Data no. : 86  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : LAN Mode

Data: 88 File: \\EMC-966-1\test data\2021\X\xin pu si.EM6 (88)

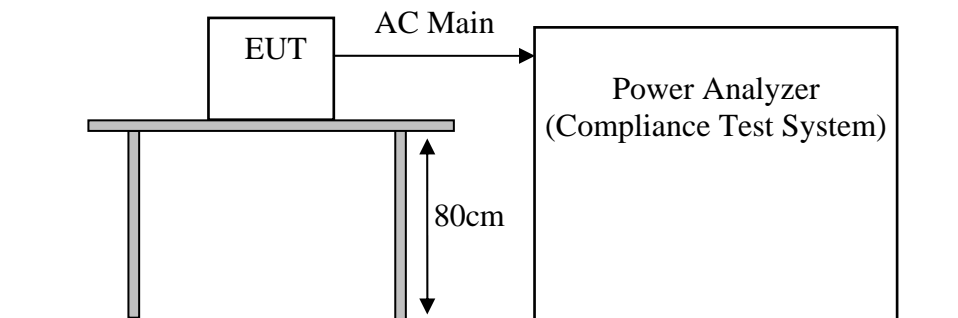
Date: 2021-04-19



Site no. : 1# 966 Chamber Data no. : 88  
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL  
Limit : EN 55032A(1-6GHZ) PK  
Env. / Ins. : Temp:24.5';Humi:48%;Press:101.82kPa  
Engineer : Sho  
EUT : Embedded Industrial Computer  
Power : DC 12V From Adapter Input AC 110V/60Hz  
M/N : CS12800RA4101A  
Test Mode : LAN Mode

#### 4.5. Harmonic Current Emissions on AC Mains Test

**RESULT** : N/A  
Test procedure : EN IEC 61000-3-2:2019  
Measured harmonics : 1~40<sup>th</sup>  
Limits : EN IEC 61000-3-2:2019



There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN IEC 61000-3-2:2019

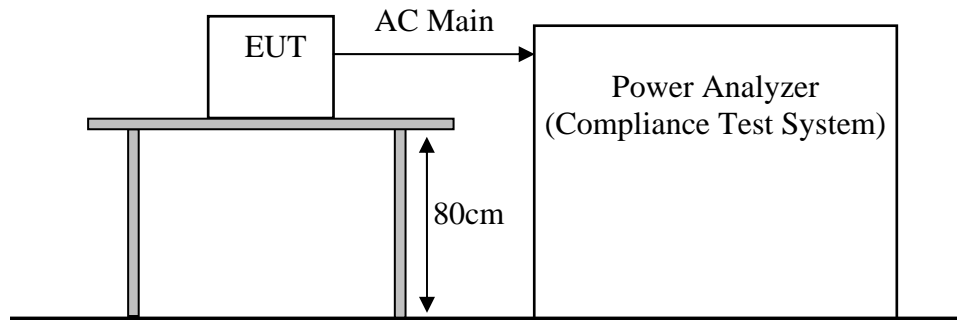
For further details, please refer to Clause 7 of EN IEC 61000-3-2:2019 which states:

“For the following categories of equipment, limits are not specified in this edition of the standard:

- equipment with a rated power of 75W or less, other than lighting equipment.”

#### 4.6. Voltage Fluctuations and Flicker on AC Mains Test

**RESULT** : **Pass**(Please refer to the following page)  
Test procedure : EN 61000-3-3:2013+A1:2019  
Limits : EN 61000-3-3:2013+A1:2019



## Test Data

### Flicker Test Summary per EN/IEC61000-3-3 Ed. 3.0 (2013) (Run time)

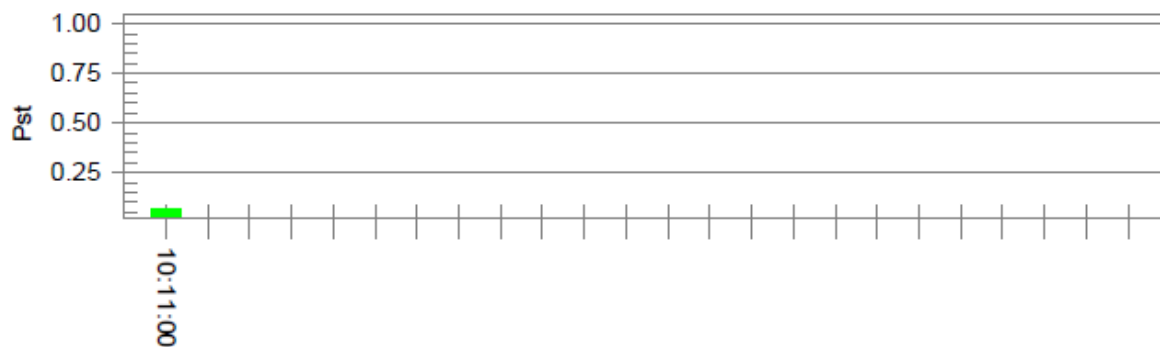
EUT: Embedded Industrial Computer M/N: CS12800RA4101A Tested by: ZANE  
Test category: All parameters (European limits) Test Margin: 100  
Test date: 2021/4/24 Start time: 10:00:39 End time: 10:11:06  
Test duration (min): 10 Data file name: F-000444.cts\_data  
Comment: WORKING  
Customer: CHIPSEE CO.,LIMITED

Test Result: Pass

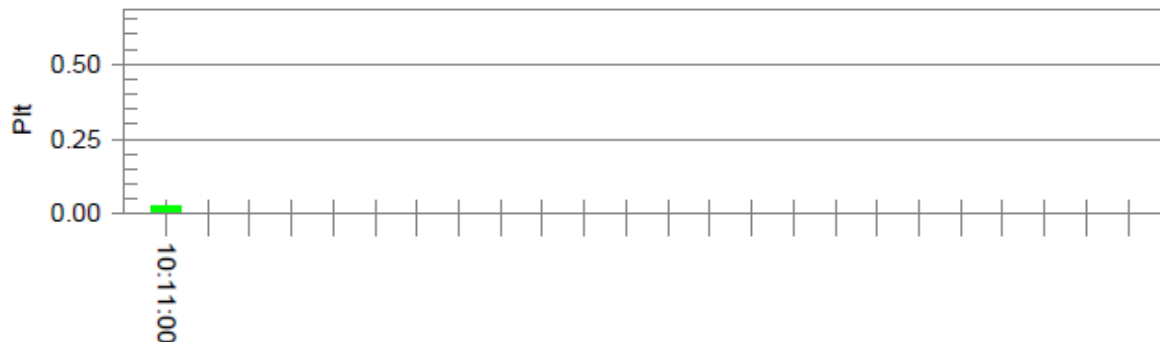
Status: Test Completed

#### Pst and limit line

#### European Limits



#### Plt and limit line



#### Parameter values recorded during the test:

Vrms at the end of test (Volt):	230.52		
T-max (mS):	0	Test limit (mS):	500.0 Pass
Highest dc (%):	0.00	Test limit (%):	3.30 Pass
Highest dmax (%):	0.00	Test limit (%):	4.00 Pass
Highest Pst (10 min. period):	0.064	Test limit:	1.000 Pass
Highest Plt (2 hr. period):	0.028	Test limit:	0.650 Pass

## 5. IMMUNITY TEST RESULT

### 5.1. Description of Performance Criteria:

#### Performance criteria A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

For audio output device: The measured acoustic interference ratio and/or the measured electrical interference during the test shall be -20dB or better(see note1)

#### Performance criteria B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criteria C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.

Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

**Note 1:** This performance criterion only using for Continuous inducted RF disturbances and Continuous RF electromagnetic field disturbances item.



## 5.2. Electrostatic Discharge Immunity Test

**RESULT** : **Pass**

Test procedure : EN 55035:2017+A11:2020

Basic standard : EN 61000-4-2:2009

Test specification : +/-4.0kV(Contact discharge)  
+/-8.0kV(Air discharge)

Number of discharges :  $\geq 10$ (Air discharge for single polarity discharge)  
 $\geq 10$  (Contact discharge for single polarity discharge)

Polarity : Positive/Negative

Performance criterion : B

### Test Setup

Date of test : May 07, 2021

Model No. : CS12800RA4101A

Input Voltage : DC 12V From Adapter Input AC 230V/50Hz

Operation Mode : TF Play, USB Play, LAN Mode

Temperature : 22.1°C

Humidity : 52%

Pressure : 101.10kPa

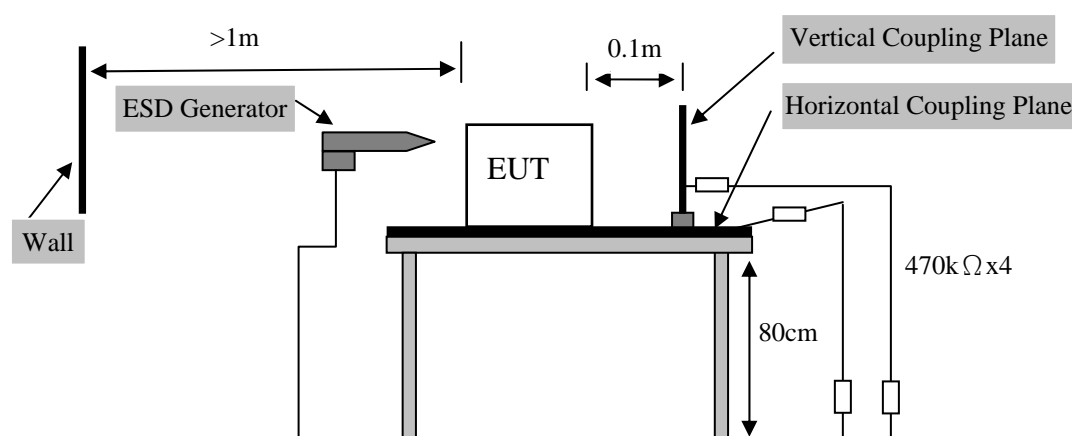


Table 1: Electrostatic Discharge Immunity Test Result

Discharge Location		Type of discharge	Result
HCP	4 points	Contact	Pass
VCP	4 points	Contact	Pass
Screen	1 point	Air	Pass
Screw	4 points	Contact	Pass
Slot	4 points	Air	Pass

*Remark: 1. The screen was flashing during the test, but self-recoverable after the test  
2. Discharge should be considered on Contact and Air and Horizontal Coupling Plane (HCP) and Vertical Coupling Plane (VCP).*

### 5.3. Radio Frequency Electromagnetic Field Immunity(R/S) Test

**RESULT** : **Pass**  
Test procedure : EN 55035:2017+A11:2020  
Basic standard : EN 61000-4-3:2006+A1:2008+A2:2010  
Frequency Range : 80-1000MHz,1800MHz, 2600MHz, 3500MHz, 5000MHz  
Performance criterion : A  
Test site : 866 Chamber

#### Test Setup

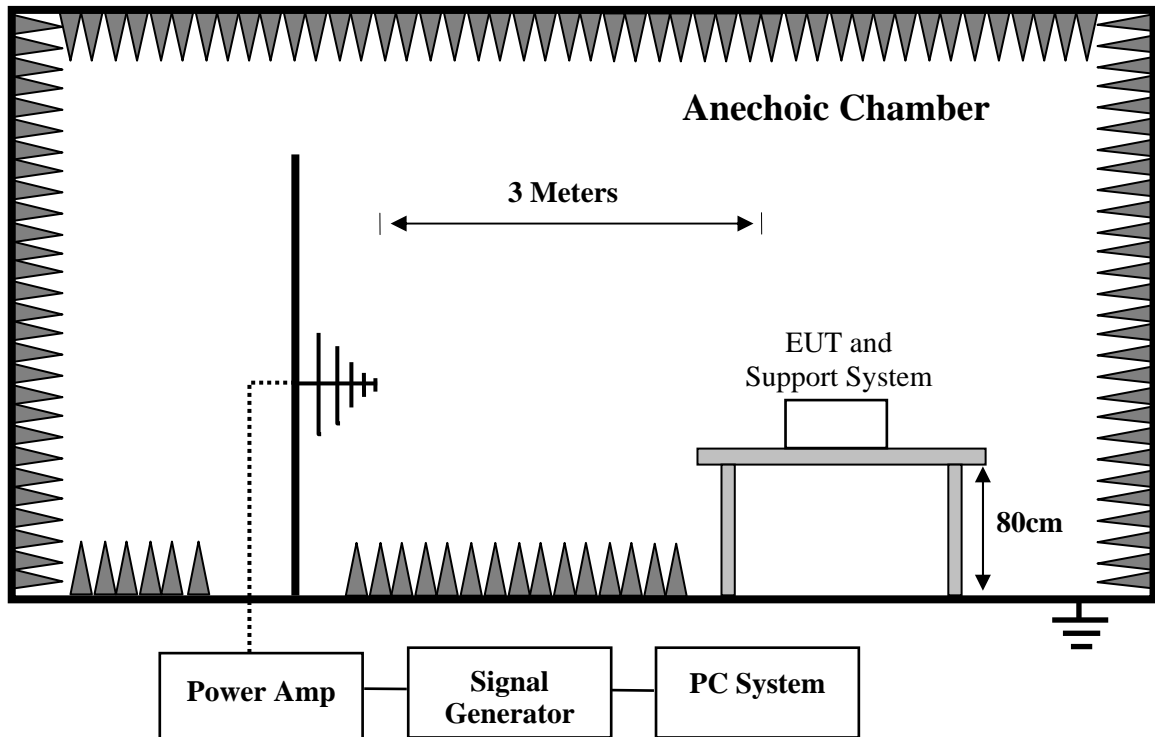
Date of test : May 07, 2021  
Model No. : CS12800RA4101A  
Input Voltage : DC 12V From Adapter Input AC 230V/50Hz  
Operation Mode : TF Play, USB Play, LAN Mode  
Temperature : 23.3°C  
Humidity : 51%  
Pressure : 101.10kPa

The EUT and its simulators were placed on a turn table which was 0.8 meter above the ground. The EUT was set 3 m away from the transmitting antenna which was mounted on an antenna tower. Both horizontal and vertical polarization of the antenna were set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a CCD camera was used to monitor EUT screen.

All the scanning conditions were as follows:

Condition of Test	Remarks
1. Field Strength	3 V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80 - 1000 MHz
4. Sweeping time of radiated	0.0015 decade/s
5. Dwell Time	at least 3 seconds



Condition of Test	Remarks
6. Field Strength	3 V/m (Severity Level 2)
7. Radiated Signal	Modulated
8. Scanning Frequency	1800MHz,2600MHz,3500MHz,5000MHz
9. Sweeping time of radiated	0.0015 decade/s
10. Dwell Time	at least 3 seconds

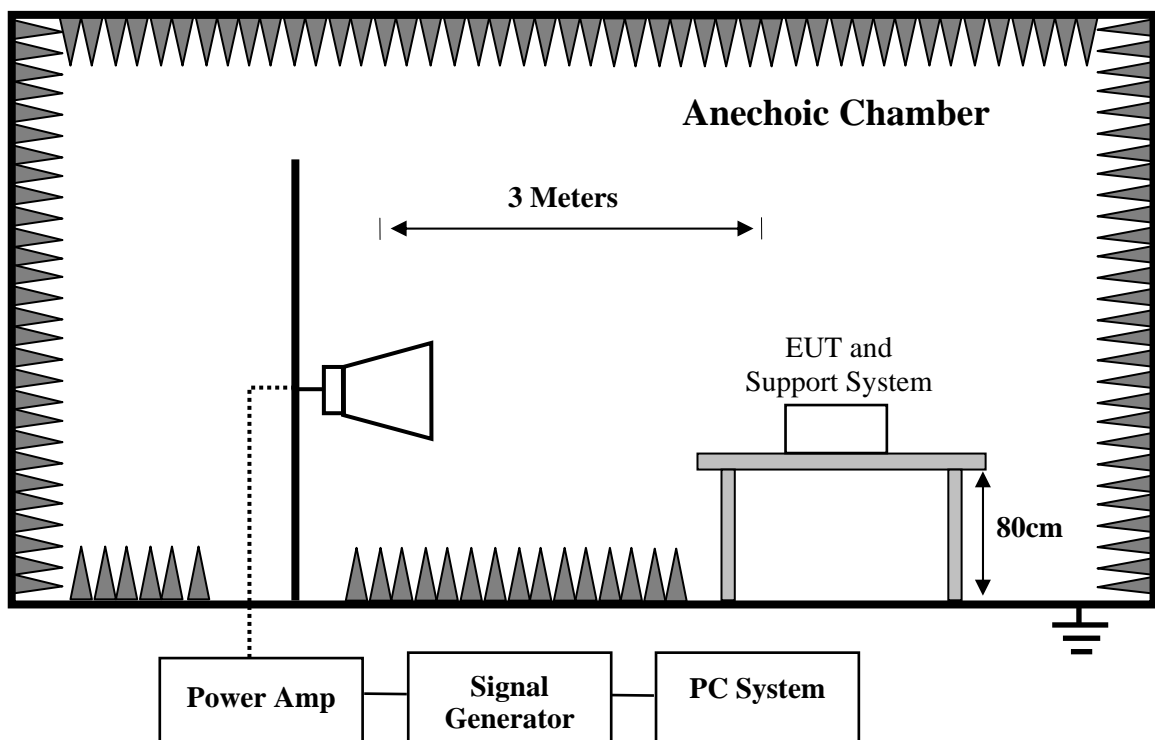


Table 2: Radio Frequency Electromagnetic Field Immunity Test Result

Field Strength (V/m)	Test Frequency (MHz)	Test mode	Polarization of antenna	Reference Level	Audio output	Limit	Interference Ratio (worst case)
3	80-1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz	USB Play	H	75dBSPL	Speaker	$\leq$ -20dB	-36 dB
			V	75dBSPL	Speaker		-38 dB

#### 5.4. Electrical Fast Transient/Burst Immunity Test

<b>RESULT</b>	<b>: Pass</b>
Test procedure	: EN 55035:2017+A11:2020
Basic standard	: EN 61000-4-4:2012
Pulseform	: Tr/Th=5/50ns
Repetition Frequency	: 5 kHz ; (100 kHz : only for single lines of xDSL equipment)
Test Duration	: 120s
Performance criterion	: B

##### Test Setup

Date of test	: May 07, 2021
Model No.	: CS12800RA4101A
Input Voltage	: DC 12V From Adapter Input AC 230V/50Hz DC 12V From Adapter Input AC 110V/60Hz
Operation Mode	: TF Play, USB Play, LAN Mode
Temperature	: 21.5°C
Humidity	: 53%
Pressure	: 101.10kPa

The EUT and its simulators were placed 0.1 m high above the ground reference plane which was a minimum 2m\*2m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1 m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

##### 1. For power input port:

The EUT was connected to the power mains by using a coupling device which coupled the EFT interference signal to AC power lines. Both polarities of the test voltage were applied during compliance test and the duration of the test were 2mins.

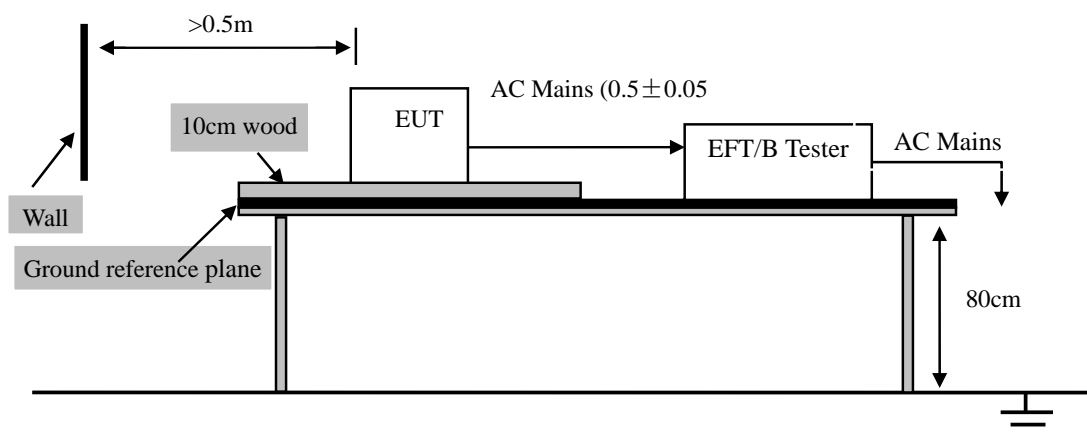


Table 5: Electrical Fast Transient/Burst Immunity Test Result

Coupling Ports		Coupling Voltage	Inject Method	Result
AC Power Ports	L	$\pm 1$ kV	Direct	Pass
	N	$\pm 1$ kV		Pass
	L-N	$\pm 1$ kV		Pass
DC Port		$\pm 0.5$ kV		Pass

*Remark: The screen was flashing during the test, but self-recoverable after the test*

## 5.5. Surge Immunity Test

**RESULT** : **Pass**  
Test procedure : EN 55035:2017+A11:2020  
Basic standard : EN 61000-4-5:2014  
Pulse form : Tr/Td = 1.2/50us  
Test Duration : 60s  
Performance criterion : B

### Test Setup

Date of test : May 07, 2021  
Model No. : CS12800RA4101A  
Input Voltage : DC 12V From Adapter Input AC 230V/50Hz  
DC 12V From Adapter Input AC 110V/60Hz  
Operation Mode : TF Play, USB Play, LAN Mode  
Temperature : 21.5°C  
Humidity : 52%  
Pressure : 101.10kPa

2  $\Omega$  effective output impedance of the generator was used for L-N test. 12  $\Omega$  effective output impedance of the generator was used for L-PE, N-PE test.

5 positive and 5 negative (polarity) tests were applied successively synchronized to the voltage phase 90°, 270° to L-N respectively. The repetition rate was 1 per minute during test.

#### 1. For input and AC power ports:

The EUT was connected to the power mains by using a coupling device which coupled the surge interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration was 1 minute.

#### 2. For signal lines and control lines ports:

None.

#### 3. For DC input and DC output power ports:

None.

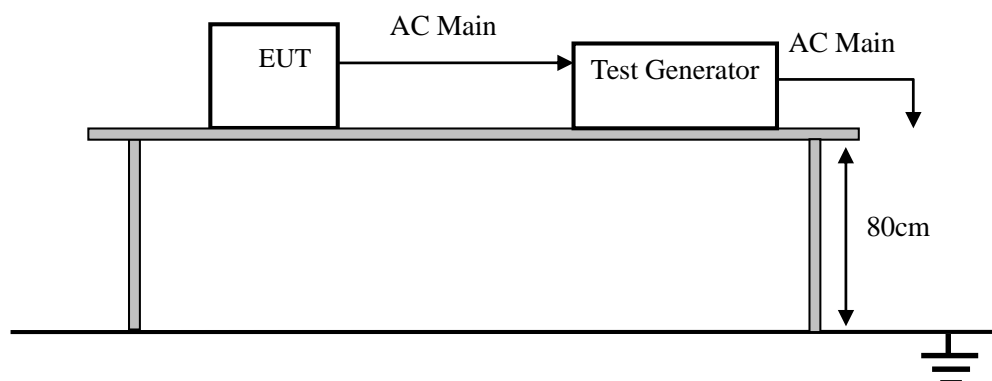




Table 4: Surge Immunity Test Result

Coupling Ports		Coupling Voltage	Coupling Phase / Result			
			0°	90°	180°	270°
AC power ports	L-N	+/-1kV Direct	/	Pass	/	Pass
B+		+/-0.5kV Direct	Pass			
B-		+/-0.5kV Direct	Pass			

*Remark: The screen was flashing during the test, but self-recoverable after the test*

## 5.6. Injected Currents Susceptibility Test

**RESULT** : **Pass**

Test procedure : EN 55035:2017+A11:2020

Basic standard : EN 61000-4-6:2014

Test specification : 3 Vr.m.s, 3 Vr.m.s - 1Vr.m.s, 1Vr.m.s,  
AM 80%, 0.15 MHz - 10 MHz, 10 MHz – 30 MHz,  
30 MHz – 80MHz

Performance criterion : A

### Test Setup

Date of test : May 07, 2021

Model No. : CS12800RA4101A

Input Voltage : DC 12V From Adapter Input AC 230V/50Hz  
DC 12V From Adapter Input AC 110V/60Hz

Operation Mode : TF Play, USB Play, LAN Mode

Temperature : 21.5°C

Humidity : 53%

Pressure : 101.10kPa

The EUT were placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) was placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT were as short as possible, and their height above the ground reference plane were between 30 and 50 mm (where possible).

The frequency range was swept from 0.15 MHz - 10 MHz, 10 MHz – 30 MHz and 30 MHz – 80MHz using 3V, 3 V - 1V, 1V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave.

The rate of sweep shall not exceed  $1.5 \times 10^{-3}$  decades/s. Where the frequency was swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.

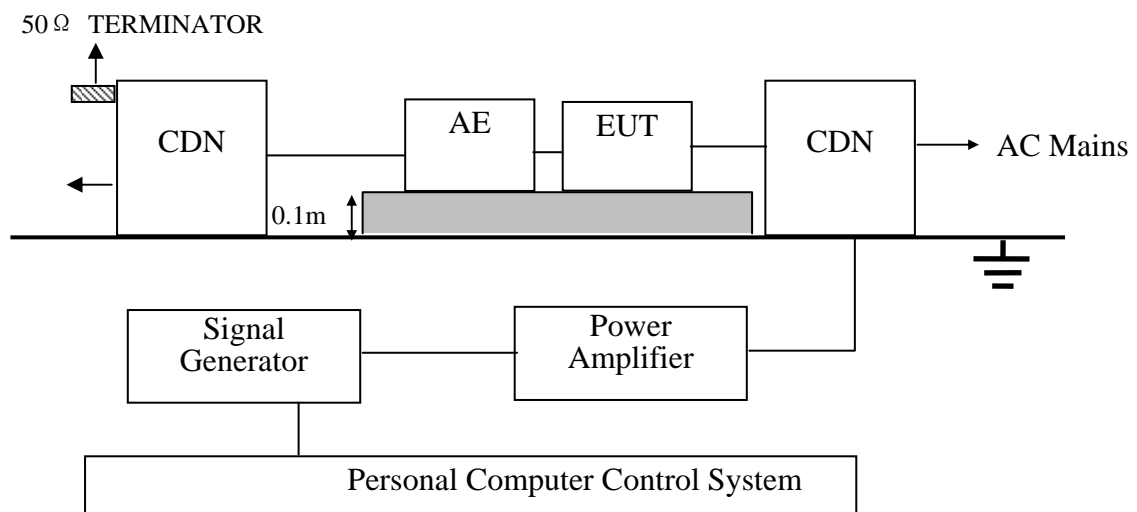


Table 5: Injected Currents Susceptibility Test Result

Voltage (V)	Test Frequency (MHz)	Test mode	Injection Method	Reference Level	Audio output	Limit	Interference Ratio (worst case)
3	0.15 –10 MHz	USB Play	CDN-M2	75dBSPL	Speaker	$\leq$ -20dB	-35 dB
3 -1	10 –30 MHz						-38 dB
1	30 –80 MHz						-40 dB

## 5.7. Power Frequency Magnetic Field Immunity Test

**RESULT** : **Pass**  
Test procedure : EN 55035:2017+A11:2020  
Basic standard : EN 61000-4-8:2010  
Test specification : 1 A/m  
Performance criterion : A

### Test Setup

Date of test : May 07, 2021  
Model No. : CS12800RA4101A  
Input Voltage : DC 12V From Adapter Input AC 230V/50Hz  
Operation Mode : TF Play, USB Play, LAN Mode  
Temperature : 23.5°C  
Humidity : 52%  
Pressure : 101.10kPa

The EUT was subjected to the test magnetic field by using the induction coil of standard dimensions (1m\*1m). The induction coil then was rotated by 90° in order to expose the EUT to the test field with different orientations.

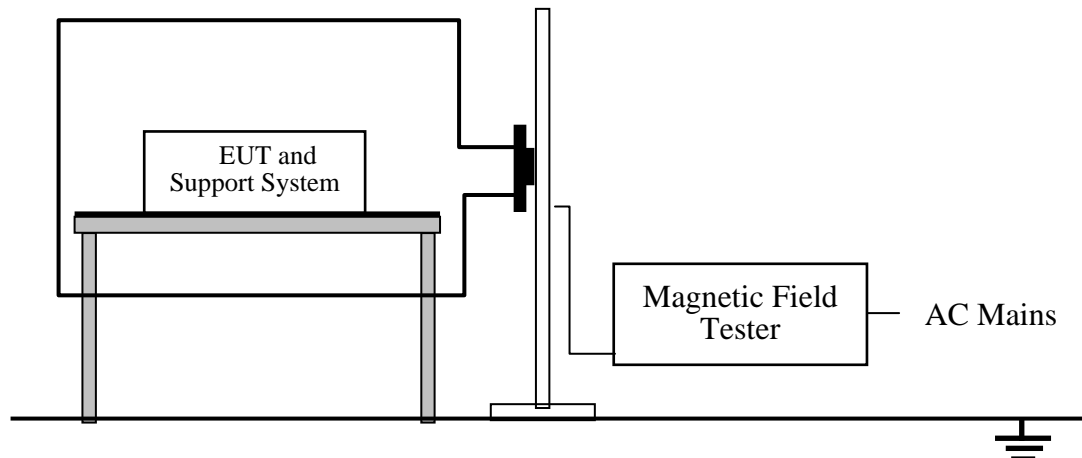


Table 6: Power Frequency Magnetic Field Immunity Test Result

Test Level	Testing Duration	Coil Orientation	Criterion	Result
1A/m	5 mins	X	A	Pass
1A/m	5 mins	Y	A	Pass
1A/m	5 mins	Z	A	Pass

*Remark: There was no change compared with initial operation during the test*

## 5.8. Voltage Dips and Short Interruptions Immunity Test

**RESULT** : **Pass**

Test procedure : EN 55035:2017+A11:2020

Basic standard : EN 61000-4-11:2004

Test specification : 0% UT ; 0.5P, Criterion: B  
70% UT; 25P/30P, Criterion: C  
0% UT; 250P/300P, Criterion: C

### Test Setup

Date of test : May 07, 2021

Model No. : CS12800RA4101A

Input Voltage : DC 12V From Adapter Input AC 230V/50Hz  
DC 12V From Adapter Input AC 110V/60Hz

Operation Mode : TF Play, USB Play, LAN Mode

Temperature : 23.5°C

Humidity : 52%

Pressure : 101.10kPa

The interruptions was introduced at selected phase angles with specified duration.  
Recorded any degradation of performance.

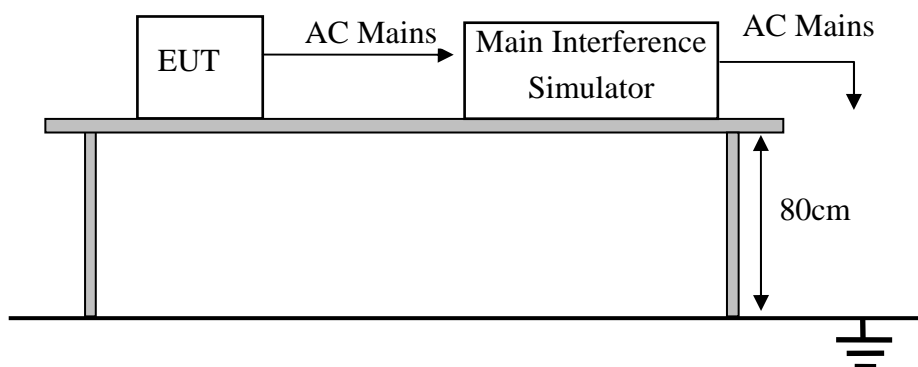


Table 7: Voltage Dips and Short Interruptions Immunity Test Result AC 230V/50Hz

Test Level % UT	Voltage Dips & Short Interruptions % UT	Duration (in period)	Criterion	Result
0	100	0.5P	B	PASS
70	30	25P	C	PASS
0	100	250P	C	PASS

*Remark: The screen was flashing during the test, but self-recoverable after the test*

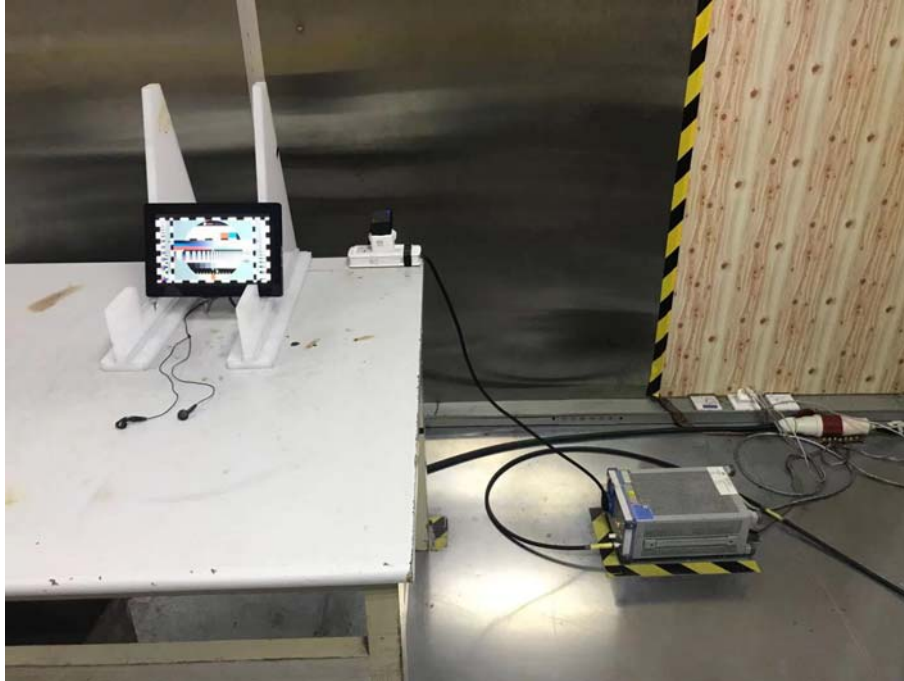
Table 8: Voltage Dips and Short Interruptions Immunity Test Result AC 110V/60Hz

Test Level % UT	Voltage Dips & Short Interruptions % UT	Duration (in period)	Criterion	Result
0	100	0.5P	B	PASS
70	30	30P	C	PASS
0	100	300P	C	PASS

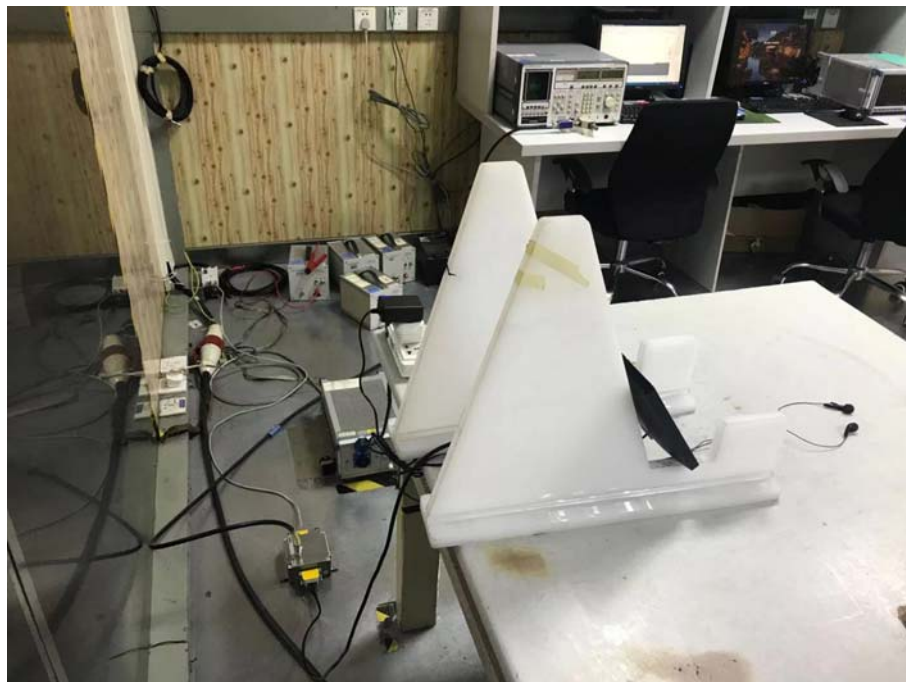
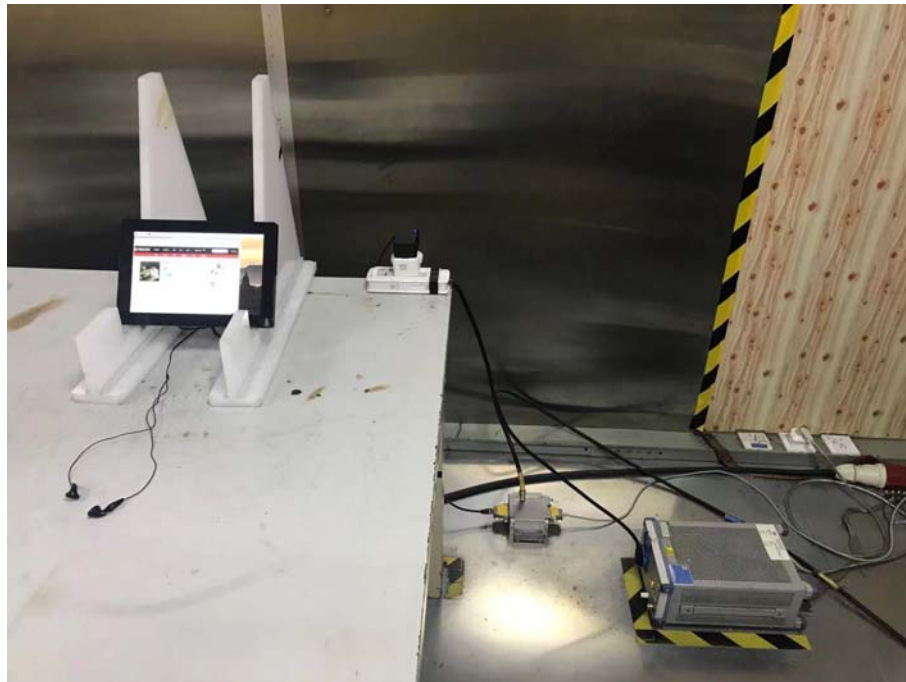
*Remark: The screen was flashing during the test, but self-recoverable after the test*

## 6. PHOTOGRAPHS OF TEST SET-UP

### 6.1.Set-up for Conducted Emission at the Mains Terminals Test

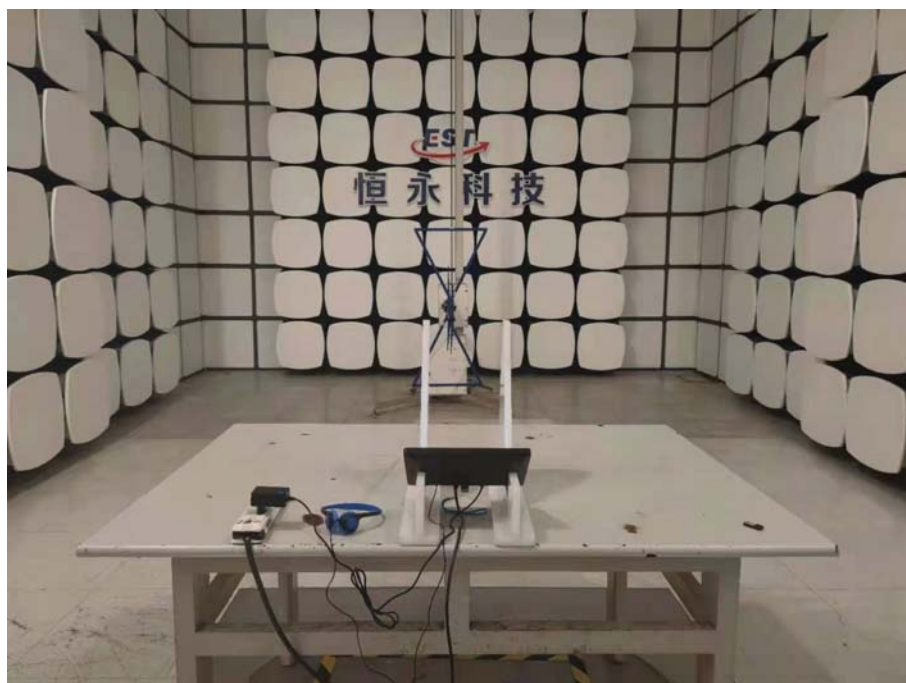
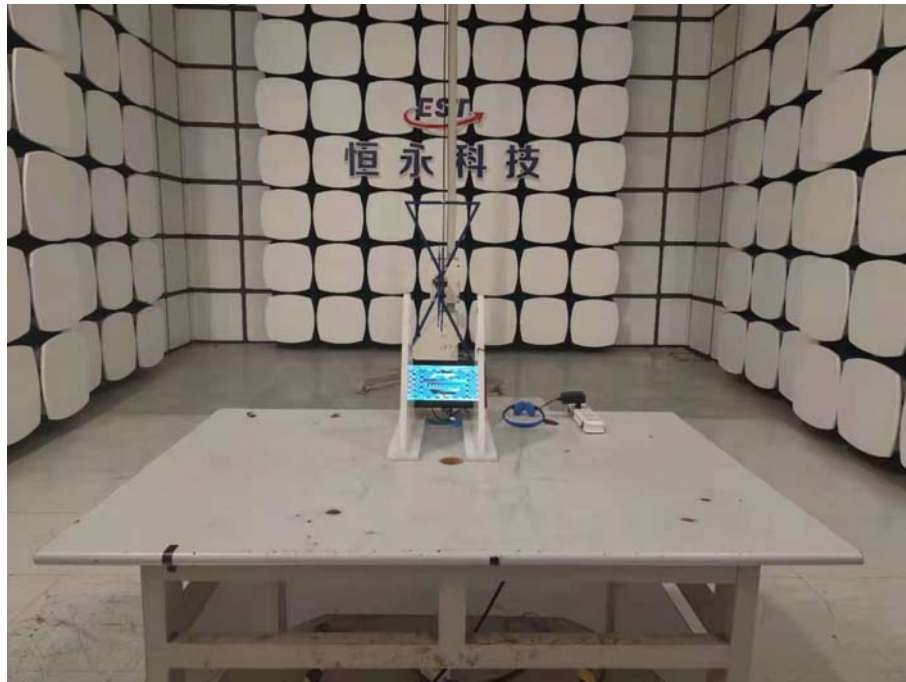


## 6.2.Set-up for Asymmetric Mode Conducted Emissions Test

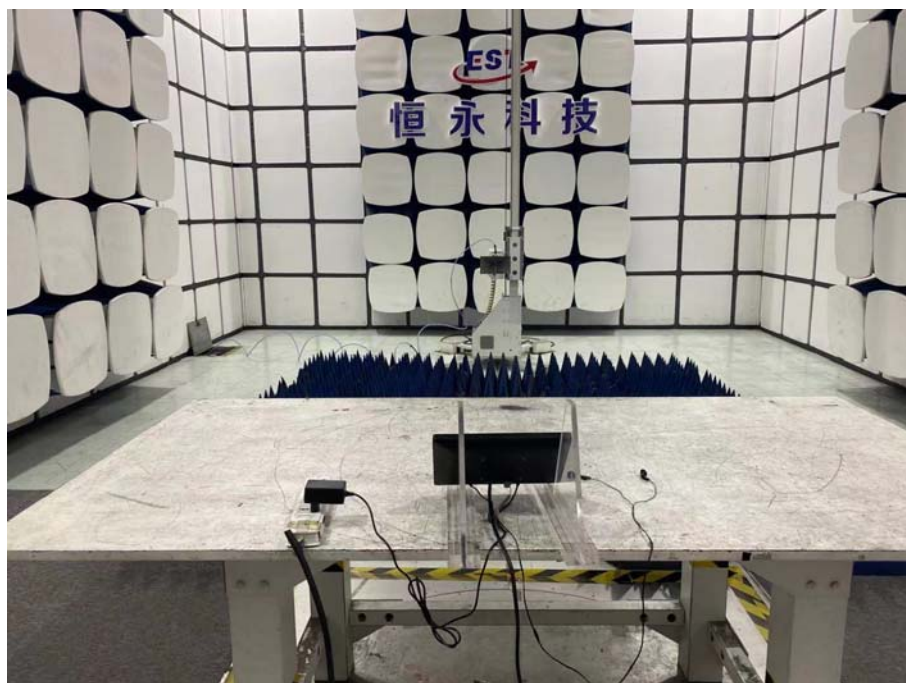
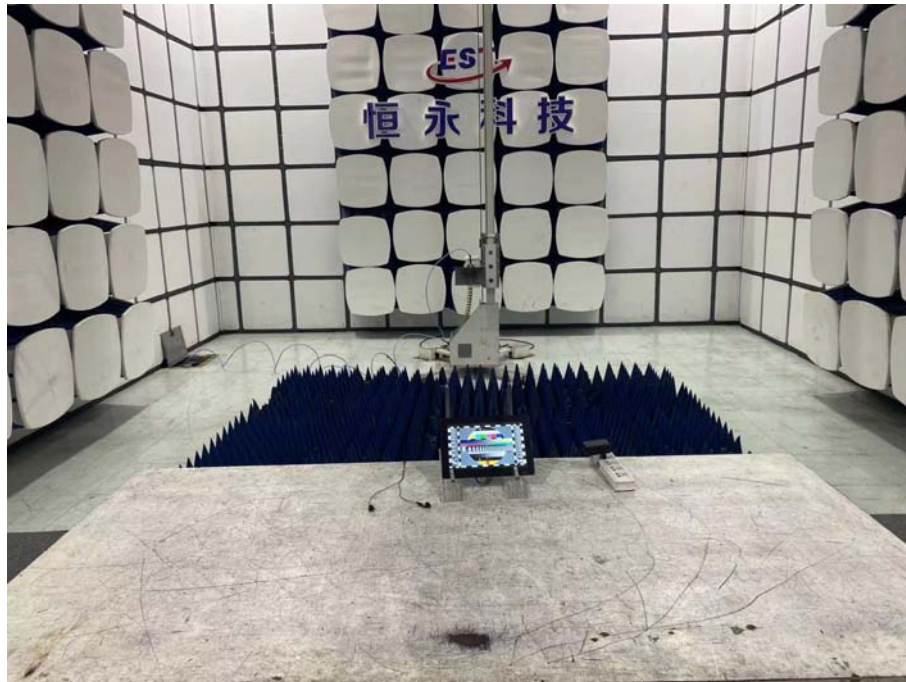




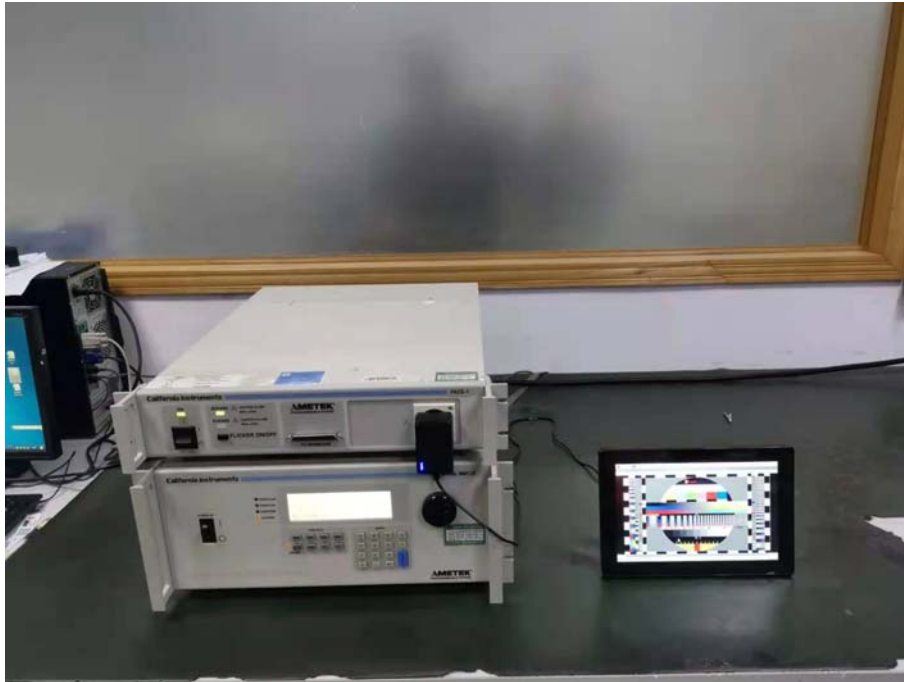
### 6.3.Set-up for Radiated Emission Test



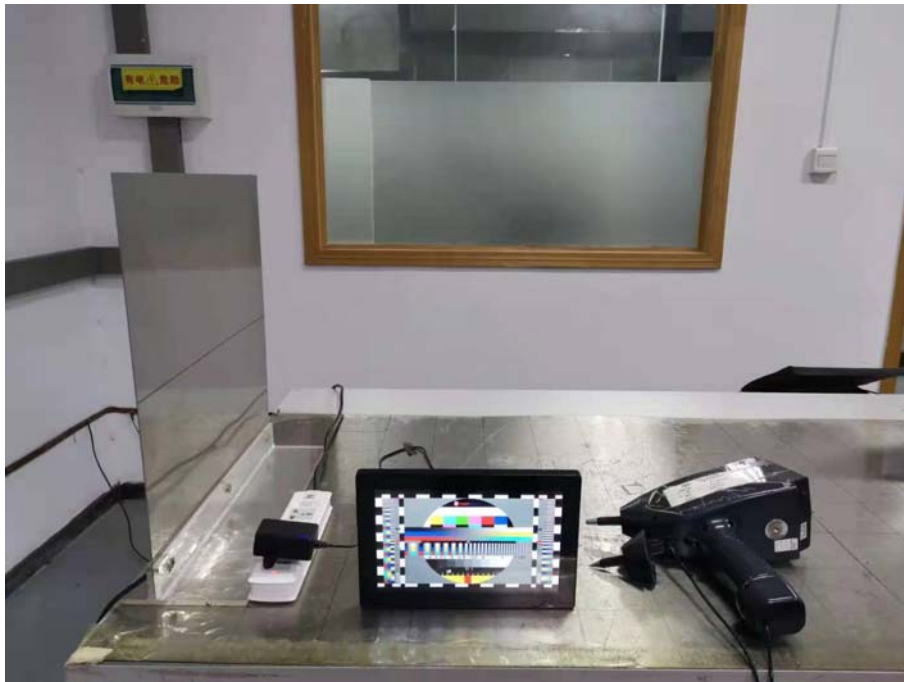
#### 6.4.Set-up for Radiated Emission Test(above 1GHz)



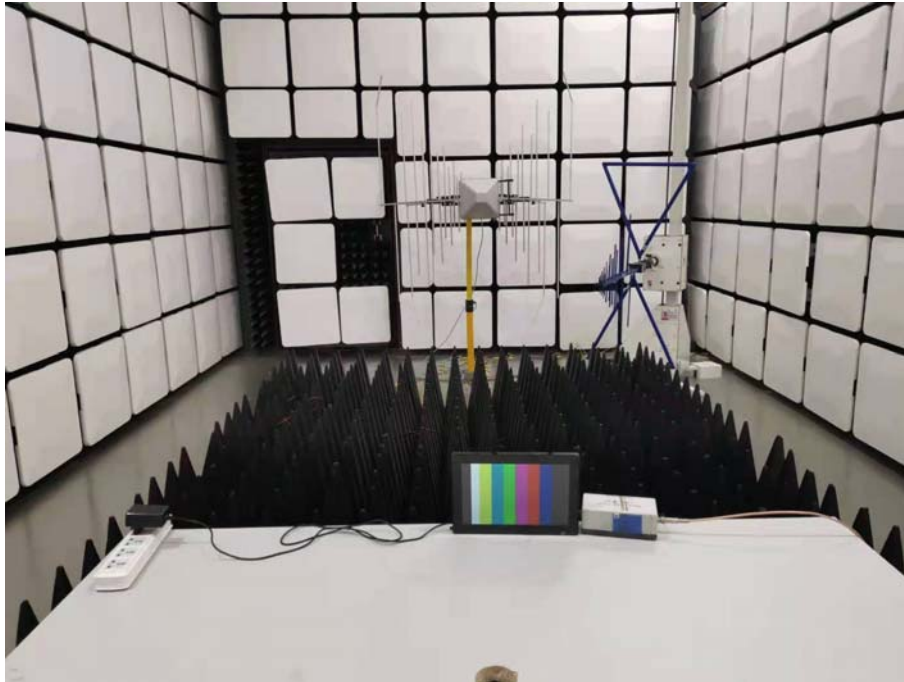
### 6.5.Set-up for Harmonic Current Emissions and Flicker on AC Mains Test



### 6.6.Set-up for Electrostatic Discharge Immunity Test



### 6.7.Set-up for Radio Frequency Electromagnetic Field Immunity(R/S) Test



### 6.8.Set-up for Electrical Fast Transient/Burst Immunity Test

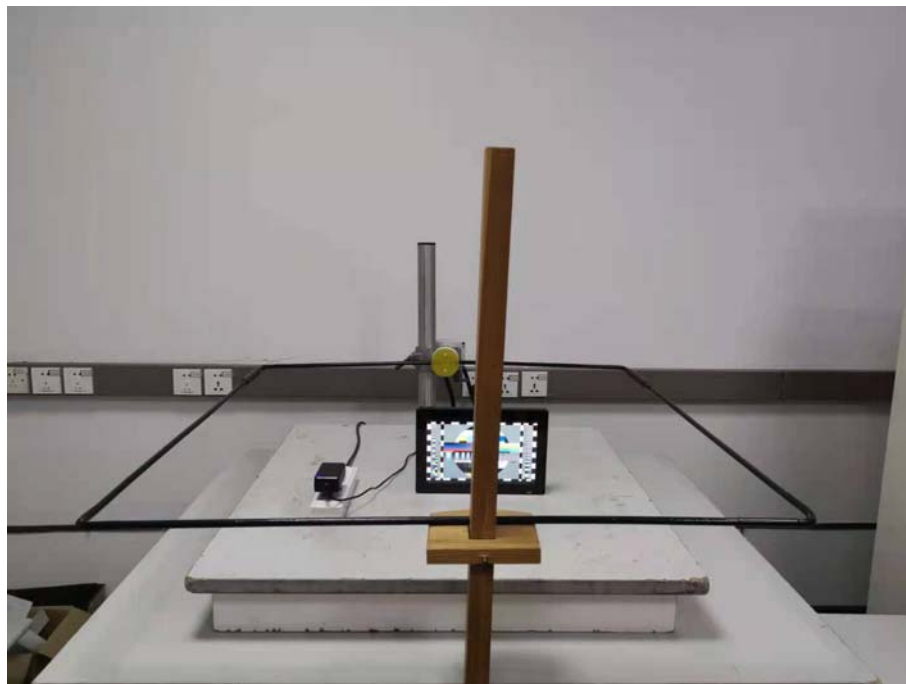




### 6.9.Set-up for Surge Immunity Test



### 6.10.Set-up for Power Frequency Magnetic Field Immunity Test



### 6.11.Set-up for Injected Currents Susceptibility Test



### 6.12.Set-up for Voltage Dips and Short Interruptions Immunity Test

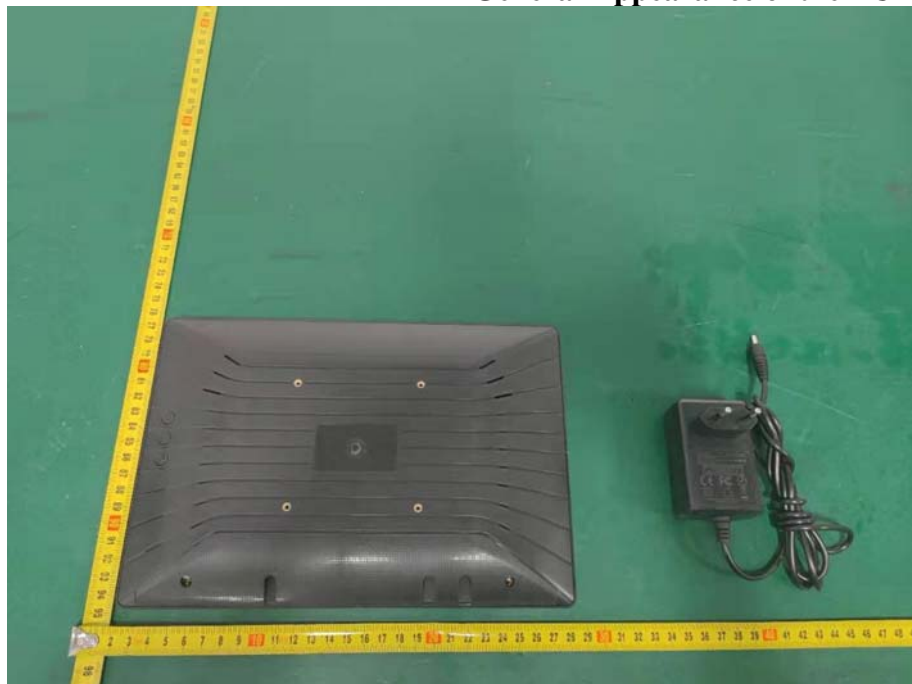


## 7. PHOTOGRAPHS OF THE EUT

**Figure 1**  
**General Appearance of the EUT**



**Figure 2**  
**General Appearance of the EUT**



**Figure 3**  
**General Appearance of the EUT**



**Figure 4**  
**General Appearance of the EUT**





**Figure 5**  
**General Appearance of the EUT**



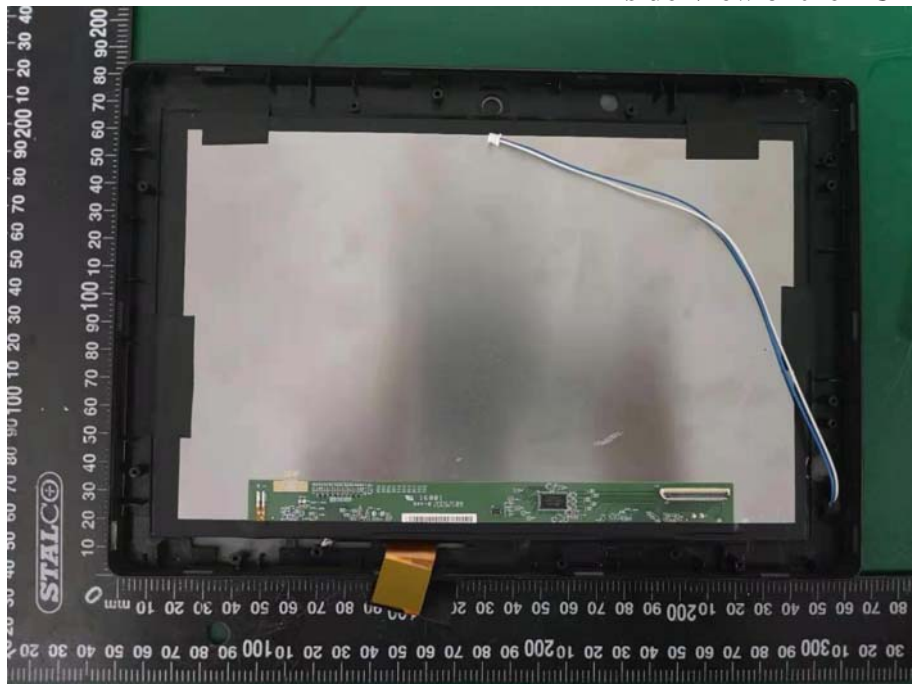
**Figure 6**  
**General Appearance of the EUT**



**Figure 7**  
**Inside View of the EUT**



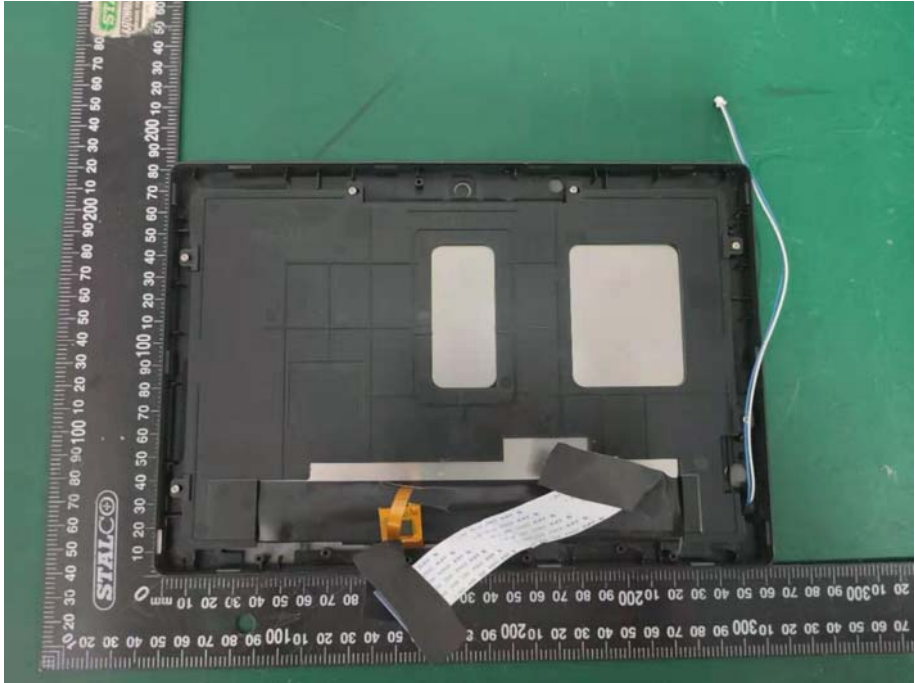
**Figure 8**  
**Inside View of the EUT**



**Figure 9**  
**Inside View of the EUT**



**Figure 10**  
**Inside View of the EUT**





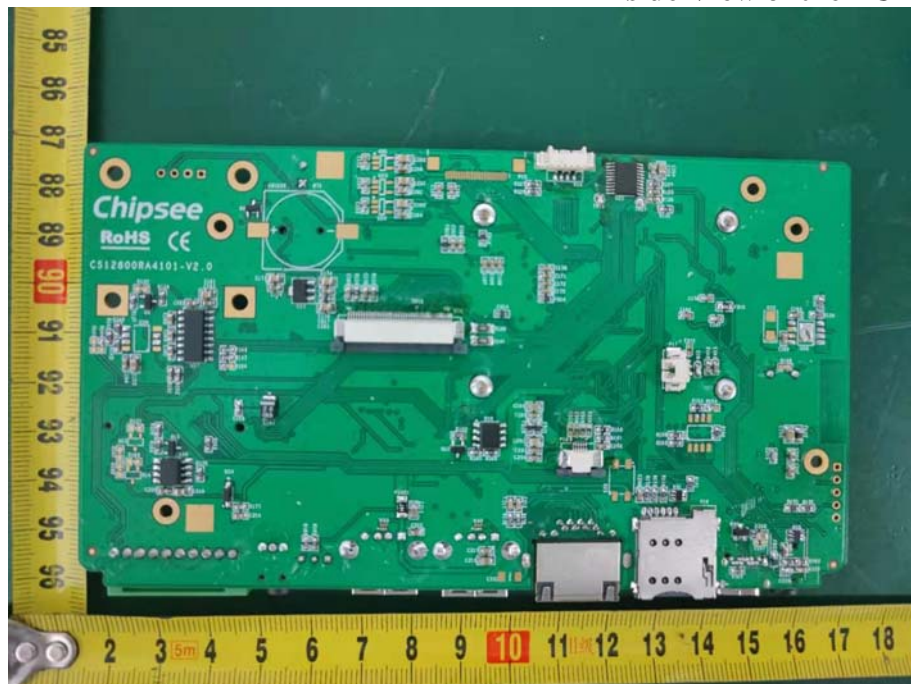
**Figure 11**  
**Inside View of the EUT**



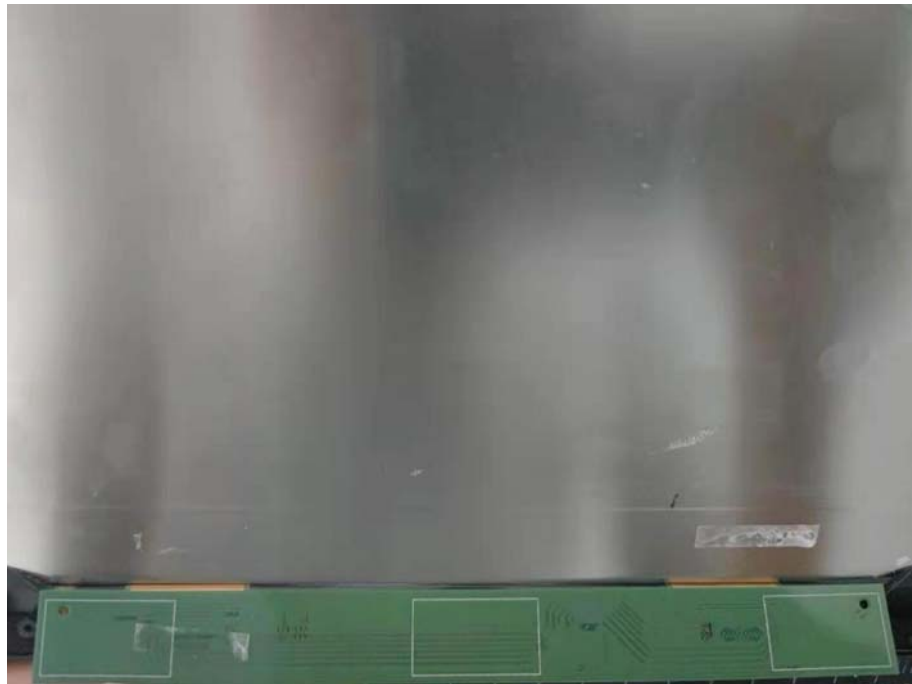
**Figure 12**  
**Inside View of the EUT**



**Figure 13**  
**Inside View of the EUT**



**Figure 14**  
**Inside View of the EUT**



**End of Test Report**